FLASH MEMORY

CMOS

32 M (4 M \times 8/2 M \times 16) BIT Dual Operation

MBM29DL320TF/BF 70/80/10

■ DESCRIPTION

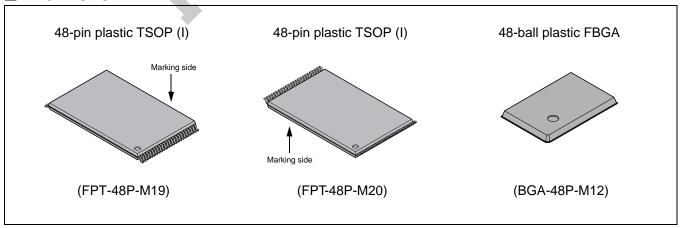
The MBM29DL320TF/BF are a 32 M-bit, 3.0 V-only Flash memory organized as 4 M bytes of 8 bits each or 2 M words of 16 bits each. These devices are designed to be programmed in-system with the standard system 3.0 V Vcc supply. 12.0 V Vpp and 5.0 V Vcc are not required for write or erase operations. The devices can also be reprogrammed in standard EPROM programmers.

(Continued)

■ PRODUCT LINE UP

Part No.		MBM29DL320TF/BF	
rait No.	70	80	10
Power Supply Voltage (V)		$Vcc = 3.0 V_{-0.3 V}^{+0.1 V}$	
Max Address Access Time (ns)	70	80	100
Max CE Access Time (ns)	70	80	100
Max OE Access Time (ns)	30	30	35

PACKAGES





(Continued)

MBM29DL320TF/BF are organized into four physical banks; Bank A, Bank B, Bank C and Bank D, which can be considered to be four separate memory arrays as far as certain operations are concerned. This device is the same as Fujitsu's standard 3 V only Flash memories with the additional capability of allowing a normal non-delayed read access from a non-busy bank of the array while an embedded write (either a program or an erase) operation is simultaneously taking place on the other bank.

In the device, a new design concept called FlexBank™ *1 Architecture is implemented. Using this concept the device can execute simultaneous operation between Bank 1, a bank chosen from among the four banks, and Bank 2, a bank consisting of the three remaining banks. This means that any bank can be chosen as Bank 1. (Refer to "1. Simultaneous Operation" in "■FUNCTIONAL DESCRIPTION".)

The standard device offers access times 70 ns, 80 ns and 100 ns, allowing operation of high-speed microprocessors without the wait. To eliminate bus contention the device has separate chip enable (\overline{CE}) , write enable (\overline{WE}) and output enable (\overline{OE}) controls.

This device consists of pin and command set compatible with JEDEC standard E²PROMs. Commands are written to the command register using standard microprocessor write timings. Register contents serve as input to an internal state-machine which controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the device is similar to reading from 5.0 V and 12.0 V Flash or EPROM devices.

The device is programmed by executing the program command sequence. This will invoke the Embedded Program Algorithm™ which is an internal algorithm that automatically times the program pulse widths and verifies proper cell margin. Typically each sector can be programmed and verified in about 0.5 seconds. Erase is accomplished by executing the erase command sequence. This will invoke the Embedded Erase Algorithm™ which is an internal algorithm that automatically preprograms the array if it is not already programmed before executing the erase operation. During erase, the device automatically times the erase pulse widths and verifies the proper cell margin.

A sector is typically erased and verified in 0.2 second (if already completely preprogrammed) .

The device also features a sector erase architecture. The sector mode allows each sector to be erased and reprogrammed without affecting other sectors. The device is erased when shipped from the factory.

The device features single 3.0 V power supply operation for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations. A low Vcc detector automatically inhibits write operations on the loss of power. The end of program or erase is detected by \overline{Data} Polling of DQ_7 , by the Toggle Bit feature on DQ_6 , or the RY/\overline{BY} output pin. Once a program or erase cycle has been completed, the device internally resets to the read mode.

The device also has a hardware RESET pin. When this pin is driven low, execution of any Embedded Program Algorithm or Embedded Erase Algorithm is terminated. The internal state machine is then reset to the read mode. The RESET pin may be tied to the system reset circuitry. Therefore if a system reset occurs during the Embedded ProgramTM *2 Algorithm or Embedded EraseTM *2 Algorithm, the device is automatically reset to the read mode and have erroneous data stored in the address locations being programmed or erased. These locations need rewriting after the Reset. Resetting the device enables the system's microprocessor to read the boot-up firmware from the Flash memory.

Fujitsu's Flash technology combines years of EPROM and E²PROM experience to produce the highest levels of quality, reliability, and cost effectiveness. The device memory electrically erases the entire chip or all bits within a sector simultaneously via Fowler-Nordhiem tunneling. The bytes/words are programmed one byte/word at a time using the EPROM programming mechanism of hot electron injection.

- *1: FlexBank™ is a trademark of Fujitsu Limited.
- *2: Embedded Erase™ and Embedded Program™ are trademarks of Advanced Micro Devices, Inc.

■ FEATURES

- 0.17 μm Process Technology
- Simultaneous Read/Write Operations (Dual Bank)
- FlexBank™

Bank A: 4 Mbit (8 KB \times 8 and 64 KB \times 7)

Bank B: 12 Mbit (64 KB \times 24) Bank C: 12 Mbit (64 KB \times 24) Bank D: 4 Mbit (64 KB \times 8)

Two virtual Banks are chosen from the combination of four physical banks (Refer to "FlexBank™ Architecture Table" and "Example of Virtual Banks Combination Table" in ■FUNCTIONAL DESCRIPTION)

Host system can program or erase in one bank, and then read immediately and simultaneously from the other bank with zero latency between read and write operations.

Read-while-erase

Read-while-program

• Single 3.0 V Read, Program, and Erase

Minimizes system level power requirements

Compatible with JEDEC-standard Commands

Uses same software commands as E2PROMs

Compatible with JEDEC-standard World-wide Pinouts

48-pin TSOP (I) (Package suffix: TN – Normal Bend Type, TR – Reversed Bend Type)

48-ball FBGA (Package suffix : PBT)

• Minimum 100,000 Program/Erase Cycles

• High Performance

70 ns maximum access time

Sector Erase Architecture

Eight 4 K word and sixty-three 32 K word sectors in word mode

Eight 8 K byte and sixty-three 64 K byte sectors in byte mode

Any combination of sectors can be concurrently erased. Also supports full chip erase.

• Boot Code Sector Architecture

T = Top sector

B = Bottom sector

• Hidden ROM (Hi-ROM) Region

256 byte of Hi-ROM, accessible through a new "Hi-ROM Enable" command sequence

Factory serialized and protected to provide a secure electronic serial number (ESN)

WP/ACC Input Pin

At V_{\perp} , allows protection of "outermost" 2×8 bytes on boot sectors, regardless of sector protection/unprotection status.

At VIH, allows removal of boot sector protection

At V_{ACC}, increases program performance

Embedded Erase™*Algorithms

Automatically pre-programs and erases the chip or any sector

Embedded Program^{™*} Algorithms

Automatically writes and verifies data at specified address

• Data Polling and Toggle Bit feature for detection of program or erase cycle completion

Ready/Busy Output (RY/BY)

Hardware method for detection of program or erase cycle completion

Automatic Sleep Mode

When addresses remain stable, automatically switch themselves to low power mode.

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3

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- Low Vcc write inhibit ≤ 2.5 V
- Erase Suspend/Resume

Suspends the erase operation to allow a read data and/or program in another sector within the same device

• Sector Group Protection

Hardware method disables any combination of sector groups from program or erase operations

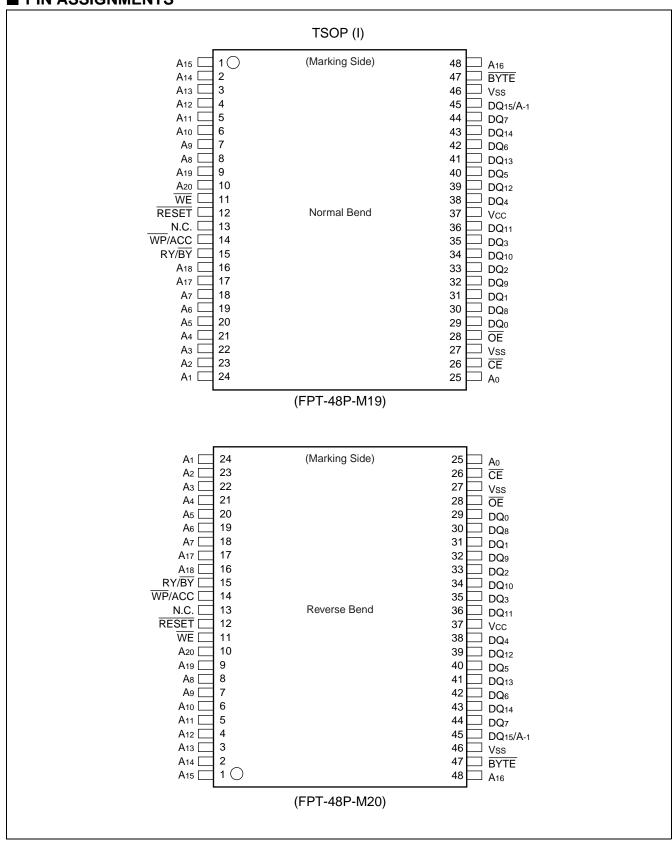
- Sector Group Protection Set function by Extended sector group protection command
- Fast Programming Function by Extended Command
- Temporary Sector Group Unprotection
 Temporary sector group unprotection via the RESET pin.
- In accordance with CFI (Common Flash Memory Interface)

Bank and Sector Organization Table

Device Part Number	Bank 1	Bank 2	Bank 3	Bank 4
MBM29DL320TF	Bank A (SA70 to 56)	Bank B (SA55 to 32)	Bank C (SA31 to 8)	Bank D (SA7 to 0)
MBM29DL320BF	Bank A (SA0 to 14)	Bank B (SA15 to 38)	Bank C (SA39 to 62)	Bank D (SA63 to 70)

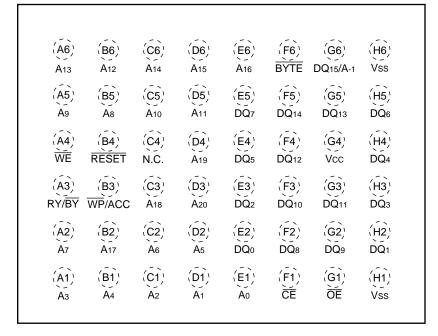
^{*:} Embedded Erase™ and Embedded Program™ are trademarks of Advanced Micro Devices, Inc.

■ PIN ASSIGNMENTS



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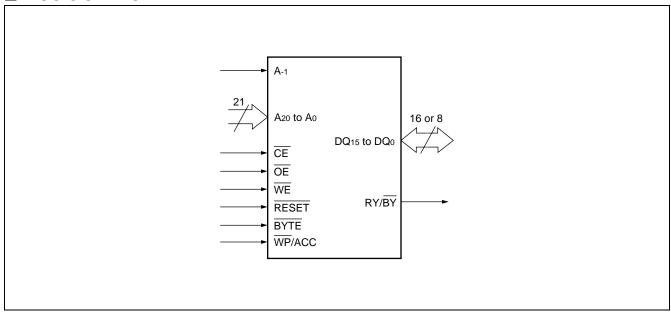


(BGA-48P-M12)

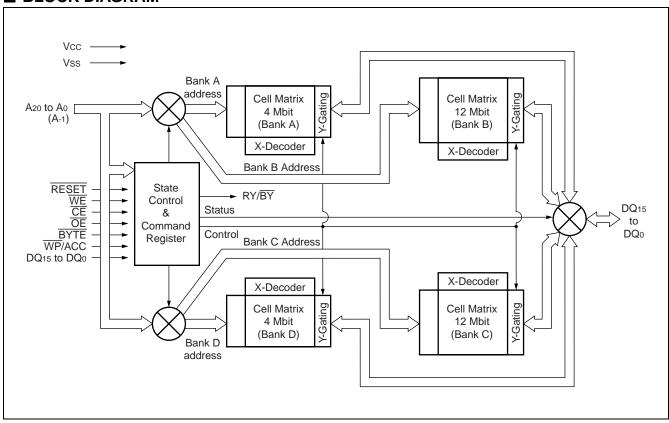
■ PIN DESCRIPTION

Pin	Function
A ₂₀ to A ₀ , A ₋₁	Address Input
DQ ₁₅ to DQ ₀	Data Input/Output
CE	Chip Enable
ŌĒ	Output Enable
WE	Write Enable
RY/ BY	Ready/Busy Output
RESET	Hardware Reset Pin/Temporary Sector Group Unprotection
BYTE	Selects 8-bit or 16-bit mode
WP/ACC	Hardware Write Protection/Program Acceleration
N.C.	No Internal Connection
Vss	Device Ground
Vcc	Device Power Supply

■ LOGIC SYMBOL



■ BLOCK DIAGRAM



■ DEVICE BUS OPERATION

MBM29DL320TF/BF User Bus Operations Table (BYTE = VIH)

Operation	CE	OE	WE	Αo	A 1	A 2	Аз	A 6	A ₉	DQ ₁₅ to	RESET	WP/ ACC
Auto-Select Manufacturer Code *1	L	L	Н	L	L	L	L	L	VID	Code	Н	Х
Auto-Select Device Code *1	L	L	Н	Н	L	L	L	L	VID	Code	Н	Х
Extended Auto-Select Device	L	L	Н	L	Н	Н	Н	L	VID	Code	Н	Х
Code *1	L	L	Н	Н	Н	Н	Н	L	VID	Code	Н	Х
Read *3	L	L	Н	Ao	A ₁	A ₂	Аз	A 6	A 9	D ouт	Н	Х
Standby	Н	Х	Х	Χ	Χ	Х	Χ	Χ	Х	High-Z	Н	Х
Output Disable	L	Н	Н	Χ	Χ	Х	Χ	Χ	Х	High-Z	Н	Х
Write (Program/Erase)	L	Н	L	Ao	A 1	A ₂	Аз	A 6	A 9	Dın	Н	Х
Enable Sector Group Protection *2, *4	L	VID	T	L	Н	L	L	L	VID	Х	Н	Х
Verify Sector Group Protection	L	L	Н	L	Н	L	L	L	VID	Code	Н	Х
Temporary Sector Group Unprotection *5	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	VID	Х
Reset (Hardware) /Standby	Х	Х	Х	Χ	Χ	Х	Х	Х	Х	High-Z	L	Х
Boot Block Sector Write Protection	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	L

Legend: L = V_{IL}, H = V_I, X = V_I or V_I, T = Pulse input. See "■DC CHARACTERISTICS" for voltage levels.

^{*1:} Manufacturer and device codes may also be accessed via a command register write sequence. See "MBM29DL320TF/BF Command Definitions Table".

^{*2:} Refer to section on "8. Sector Group Protection" in ■FUNCTIONAL DESCRIPTION.

^{*3:} $\overline{\text{WE}}$ can be V_{IL} if $\overline{\text{OE}}$ is V_{IL} , $\overline{\text{OE}}$ at V_{IH} initiates the write operations.

^{*4:} Vcc = 2.7 V to 3.1 V

^{*5:} Also used for the extended sector group protection.

MBM29DL320TF/BF User Bus Operations Table ($\overline{BYTE} = V_{IL}$)

Operation	CE	OE	WE	DQ ₁₅ /A ₋₁	Ao	A 1	A 2	Аз	A 6	A 9	DQ7 to DQ0	RESET	WP/ ACC
Auto-Select Manufacturer Code *1	L	L	Н	L	L	L	L	L	L	VID	Code	Н	Х
Auto-Select Device Code *1	L	L	Н	L	Н	L	L	L	L	VID	Code	Н	Х
Extended Auto-Select	L	L	Н	L	L	Н	Н	Н	L	VID	Code	Н	Х
Device Code *1	L	L	Н	L	Н	Н	Н	Н	L	VID	Code	Н	Х
Read *3	L	L	Н	A -1	A ₀	A 1	A ₂	Аз	A ₆	A 9	D оит	Н	Х
Standby	Н	Х	Х	Х	Χ	Х	Χ	Χ	Χ	Х	High-Z	Н	Х
Output Disable	L	Н	Н	Х	Χ	Х	Χ	Χ	Χ	Х	High-Z	Н	Х
Write (Program/Erase)	L	Н	L	A -1	A ₀	A 1	A ₂	Аз	A 6	A 9	Din	Н	Х
Enable Sector Group Protection *2, *4	L	VID	T	L	L	Н	L	L	L	VID	Х	Н	Х
Verify Sector Group Protection *2, *4	L	L	Н	L	L	Н	L	L	L	VID	Code	Н	Х
Temporary Sector Group Unprotection *5	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	VID	Х
Reset (Hardware) / Standby	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	High-Z	L	Х
Boot Block Sector Write Protection	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	L

Legend: L = V_{IL}, H = V_I, X = V_I or V_I, ¬¬¬ = Pulse input. See "■DC CHARACTERISTICS" for voltage levels.

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MBM29DL320TF/BF Command Definitions Table

Comman sequenc		Bus write cycles	First write		Secon write		Third write o		Fourtl read/ cyc	write	Fifth write		Sixth write	
		req'd	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data
Read/Reset*1	Word Byte	1	XXXh	F0h		_		_	_	_		_		_
	Word	_	555h		2AAh		555h							
Read/Reset*1	Byte	3	AAAh	AAh	555h	55h	AAAh	F0h	RA	RD		_		
Autoselect	Word	3	555h	AAh	2AAh	55h	(BA) 555h	90h						
Autoselect	Byte	3	AAAh	AAII	555h	3311	(BA) AAAh	9011				_		
Program	Word	4	555h	AAh	2AAh	55h	555h	A0h	PA	PD				
i rogram	Byte	7	AAAh	74711	555h	3311	AAAh	Aon	1 /	יו				
Program Susp	end	1	BA	B0h	_	—	_	_	_	_	_	_		_
Program Resu	me	1	BA	30h			_	_	_	—	—	_	—	
Chip Erase	Word	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	555h	10h
0111p 21000	Byte	Ŭ	AAAh	70	555h	0011	AAAh	0011	AAAh	70 (11	555h	0011	AAAh	1011
Sector Erase	Word	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	SA	30h
Coolor Eraco	Byte		AAAh	70 01	555h	0011	AAAh	0011	AAAh	70 (11	555h	0011		0011
Erase Suspen	d	1	BA	B0h			_	_	_	—	—	_	—	
Erase Resume)	1	BA	30h		—	_	_	_					
Set to	Word	3	555h	AAh	2AAh	55h	555h	20h	_		_	_		
Fast Mode	Byte		AAAh		555h		AAAh							
Fast	Word	2	XXXh	A0h	PA	PD	_		_		_	_		
Program *2	Byte	_	XXXh	7 1011										
Reset from	Word	2	BA	90h	XXXh	F0h*6	_		_		_	_		
Fast Mode *2	Byte		BA		XXXh									
Extended Sector Group	Word	4	XXXh	60h	SPA	60h	SPA	40h	SPA	SD				
Protection *3	Byte	4	XXXII	0011	SFA	0011	SFA	4011	SFA	30				
Query *4	Word	1	(BA) 55h	98h										
Query	Byte	'	(BA) AAh	3011										
Hi-ROM	Word	3	555h	AAh	2AAh	55h	555h	- 88h						
Entry	Byte	J	AAAh	7 0-111	555h	3311	AAAh	0011						

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Commai sequenc		Bus write cycles	First write		Seco bu write	IS	Third I		Fourth read/v cyc	write	Fifth write		Sixth bus write cycle		
	Word	req'd	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	
Hi-ROM	Word		555h		2AAh		555h								
Hi-ROM Program *5	Byte	4	AAAh	AAh	555h 55	55h	AAAh	A0h	(HRA) PA	PD	_		_	_	
Hi-ROM	Word 4	4	555h	AAh	2AAh	55h	(HRBA) 555h) 90h	XXXh	00h					
Exit *5		Byte	Byte		AAAh	AAII	555h	5511	(HRBA) AAAh	3011	AAAII	OOII	_		

- *1 : Both of these reset commands are equivalent.
- *2: This command is valid during Fast Mode.
- *3 : This command is valid while $\overline{RESET} = V_{ID}$.
- *4: The valid address are A6 to A0.
- *5 : This command is valid during Hi-ROM mode.
- *6: The date "00h" is also acceptable.
- Notes: Address bits A₂₀ to A₁₁ = X = "H" or "L" for all address commands except or Program Address (PA), Sector Address (SA), Bank Address (BA).
 - Bus operations are defined in "MBM29DL320TF/BF User Bus Operations Tables (BYTE = V_{IH} and BYTE = V_{IL})" (■DEVICE BUS OPERATION).
 - RA = Address of the memory location to be read
 - PA = Address of the memory location to be programmed Addresses are latched on the falling edge of the write pulse.
 - SA = Address of the sector to be erased. The combination of A₂₀, A₁₉, A₁₈, A₁₇, A₁₆, A₁₅, A₁₄, A₁₃, and A₁₂ will uniquely select any sector.
 - BA = Bank Address (A20 to A18)
 - RD = Data read from location RA during read operation.
 - PD = Data to be programmed at location PA. Data is latched on the rising edge of write pulse.
 - SPA = Sector group address to be protected. Set sector group address and $(A_6, A_3, A_2, A_1, A_0) = (0, 0, 0, 1, 0)$.
 - SD = Sector group protection verify data. Output 01h at protected sector group addresses and output 00h at unprotected sector group addresses.
 - HRA = Address of the Hi-ROM area

29DL320TF (Top Boot Type) Word Mode: 1FFF80h to 1FFFFh

Byte Mode: 3FFF00h to 3FFFFh

29DL320BF (Bottom Boot Type) Word Mode: 000000h to 00007Fh

Byte Mode: 000000h to 0000FFh

HRBA = Bank Address of the Hi-ROM area

29DL320TF (Top Boot Type) : $A_{20} = A_{19} = A_{18} = 1$

29DL320BF (Bottom Boot Type) : $A_{20} = A_{19} = A_{18} = 0$

• The system should generate the following address patterns :

Word Mode: 555h or 2AAh to addresses A10 to A0

Byte Mode: AAAh or 555h to addresses A₁₀ to A₀, and A₋₁

- Both Read/Reset commands are functionally equivalent, resetting the device to the read mode.
- The command combinations not described in "MBM29DL320TF/BF Command Definitions Table" are illegal.

MBM29DL320TF Sector Group Protection Verify Autoselect Codes Table

Туре		A ₂₀ to A ₁₂	A 6	Аз	A 2	A 1	Ao	A -1*1	Code (HEX)
Manufacture's Cod	de	BA*3	VIL	VIL	VIL	VIL	VIL	Vıl	04h
Device Code	Byte	BA*3	Vıl	VIL	Vıl	VIL	ViH	VIL	7Eh
Device Code	Word	DA 3	VIL	VIL	VIL	VIL	VIH	Х	227Eh
	Byte	BA*3	Vıl	ViH	ViH	ViH	VIL	Vıl	0Ah
Extended Device	Word	DA °	VIL	VIH	VIH	VIH	VIL	Х	220Ah
Code*4	Byte	BA*3	VIL	ViH	ViH	ViH	ViH	VIL	01h
	Word	DA °	VIL	VIH	VIH	VIH	VIH	Х	2201h
Sector Group Prot	ection	SA	VIL	VIL	VIL	ViH	VIL	Vıl	01h*2

^{*1 :} A-1 is for Byte mode.

MBM29DL320TF Expanded Autoselect Code Table

Туре	!	Code	DQ ₁₅	DQ ₁₄	DQ ₁₃	DQ ₁₂	DQ ₁₁	DQ ₁₀	DQ ₉	DQ8	DQ ₇	DQ ₆	DQ ₅	DQ ₄	DQ₃	DQ ₂	DQ₁	DQ ₀
Manufactu Code	re's	04h	A-1/0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
Device	Byte	7Eh	A-1	HZ	HZ	HZ	HZ	HZ	HZ	HZ	0	1	1	1	1	1	1	0
Code	Word	227Eh	0	0	1	0	0	0	1	0	0	1	1	1	1	1	1	0
	Byte	0Ah	A-1	HZ	HZ	HZ	HZ	HZ	HZ	HZ	0	0	0	0	1	0	1	0
Extended Device	Word	220Ah	0	0	1	0	0	0	1	0	0	0	0	0	1	0	1	0
Code	Byte	01h	A-1	HZ	HZ	HZ	HZ	HZ	HZ	HZ	0	0	0	0	0	0	0	1
	Word	2201h	0	0	1	0	0	0	1	0	0	0	0	0	0	0	0	1
Sector Group Protection		01h	A-1/0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1

HZ: High-Z

^{*2 :} Outputs 01h at protected sector group addresses and outputs 00h at unprotected sector group addresses.

^{*3:} When V_{ID} is applied to A₉, both Bank 1 and Bank 2 are put into Autoselect mode, which makes simultaneous operation unable to be executed. Consequently, specifying the bank address is not required. However, the bank address needs to be indicated when Autoselect mode is read out at command mode, because then it becomes possible to activate simultaneous operation.

^{*4 :} At WORD mode, a read cycle at address (BA) 01h (at BYTE mode, (BA) 02h) outputs device code. When 227Eh (at BYTE mode, 7Eh) is output, it indicates that two additional codes, called Extended Device Codes, will be required. Therefore the system may continue reading out these Extended Device Codes at the address of (BA) 0Eh (at BYTE mode, (BA) 1Ch), as well as at (BA) 0Fh (at BYTE mode, (BA) 1Eh).

MBM29DL320BF Sector Group Protection Verify Autoselect Codes Table

Туре		A20 to A12	A 6	Аз	A ₂	A 1	Ao	A -1*1	Code (HEX)
Manufacture's Cod	de	BA*3	VIL	VIL	VIL	VIL	VIL	VIL	04h
Device Code	Byte	BA*3	Vıl	Vıl	Vıl	VIL	Vih	VIL	7Eh
Device Code	Word	DA 3	VIL	VIL	VIL	VIL	VIH	Х	227Eh
	Byte	BA*3	Vıl	ViH	ViH	ViH	VıL	VIL	0Ah
Extended Device	Word	DA °	VIL	VIH	VIH	VIH	VIL	Х	220Ah
Code*4	Byte	BA*3	Vıl	ViH	ViH	V _{IH} V _{IH}		VIL	00h
	Word	DA °	VIL	VIH	VIH	VIH	ViH	Х	2200h
Sector Group Prot	ection	SA	VIL	VIL	VIL	ViH	VIL	VIL	01h*2

^{*1 :} A-1 is for Byte mode.

- *3: When V_{ID} is applied to A₉, both Bank 1 and Bank 2 are put into Autoselect mode, which makes simultaneous operation unable to be executed. Consequently, specifying the bank address is not required. However, the bank address needs to be indicated when Autoselect mode is read out at command mode, because then it becomes possible to activate simultaneous operation.
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MBM29DL320BF Expanded Autoselect Code Table

Туре)	Code	DQ ₁₅	DQ ₁₄	DQ ₁₃	DQ ₁₂	DQ ₁₁	DQ ₁₀	DQ ₉	DQ₃	DQ ₇	DQ ₆	DQ ₅	DQ ₄	DQ ₃	DQ ₂	DQ ₁	DQ₀
Manufactu Code	ıre's	04h	A-1/0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
Device	Byte	7Eh	A -1	HZ	HZ	HZ	HZ	HZ	HZ	HZ	0	1	1	1	1	1	1	0
Code	Word	227Eh	0	0	1	0	0	0	1	0	0	1	1	1	1	1	1	0
	Byte	0Ah	A -1	HZ	HZ	HZ	HZ	HZ	HZ	HZ	0	0	0	0	1	0	1	0
Extended Device	Word	220Ah	0	0	1	0	0	0	1	0	0	0	0	0	1	0	1	0
Code	Byte	00h	A -1	HZ	HZ	HZ	HZ	HZ	HZ	HZ	0	0	0	0	0	0	0	0
	Word	2200h	0	0	1	0	0	0	1	0	0	0	0	0	0	0	0	0
Sector Group Protection		01h	A-1/0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1

HZ: High-Z

^{*2 :} Outputs 01h at protected sector group addresses and outputs 00h at unprotected sector group addresses.

■ FLEXIBLE SECTOR-ERASE ARCHITECTURE

Sector Address Table (MBM29DL320TF)

В					Sec	tor a	addr	ess				Sector		
a n	Sec- tor		Bank Idres									size (Kbytes/	(×8) Address range	(×16) Address range
k		A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	A 11	Kwords)		
	SA0	0	0	0	0	0	0	Χ	Χ	Χ	Χ	64/32	000000h to 00FFFFh	000000h to 007FFFh
	SA1	0	0	0	0	0	1	Χ	Χ	Χ	Χ	64/32	010000h to 01FFFFh	008000h to 00FFFFh
В	SA2	0	0	0	0	1	0	Χ	Χ	Χ	Χ	64/32	020000h to 02FFFFh	010000h to 017FFFh
a n	SA3	0	0	0	0	1	1	Χ	Χ	Χ	Χ	64/32	030000h to 03FFFFh	018000h to 01FFFFh
k	SA4	0	0	0	1	0	0	Χ	Χ	Χ	Χ	64/32	040000h to 04FFFFh	020000h to 027FFFh
D	SA5	0	0	0	1	0	1	Χ	Χ	Χ	Χ	64/32	050000h to 05FFFFh	028000h to 02FFFFh
	SA6	0	0	0	1	1	0	Χ	Χ	Χ	Χ	64/32	060000h to 06FFFFh	030000h to 037FFFh
	SA7	0	0	0	1	1	1	Χ	Χ	Χ	Χ	64/32	070000h to 07FFFh	038000h to 03FFFFh
	SA8	0	0	1	0	0	0	Χ	Χ	Χ	Χ	64/32	080000h to 08FFFFh	040000h to 047FFFh
	SA9	0	0	1	0	0	1	Χ	Χ	Χ	Χ	64/32	090000h to 09FFFFh	048000h to 04FFFFh
	SA10	0	0	1	0	1	0	Χ	Χ	Χ	Χ	64/32	0A0000h to 0AFFFFh	050000h to 057FFFh
	SA11	0	0	1	0	1	1	Χ	Χ	Χ	Χ	64/32	0B0000h to 0BFFFFh	058000h to 05FFFFh
	SA12	0	0	1	1	0	0	Χ	Χ	Χ	Χ	64/32	0C0000h to 0CFFFh	060000h to 067FFFh
	SA13	0	0	1	1	0	1	Χ	Χ	Χ	Χ	64/32	0D0000h to 0DFFFFh	068000h to 06FFFFh
	SA14	0	0	1	1	1	0	Χ	Χ	Χ	Χ	64/32	0E0000h to 0EFFFFh	070000h to 077FFFh
	SA15	0	0	1	1	1	1	Χ	Χ	Χ	Χ	64/32	0F0000h to 0FFFFh	078000h to 07FFFFh
	SA16	0	1	0	0	0	0	Χ	Χ	Χ	Χ	64/32	100000h to 10FFFFh	080000h to 087FFFh
	SA17	0	1	0	0	0	1	Χ	Χ	Χ	Χ	64/32	110000h to 11FFFFh	088000h to 08FFFFh
В	SA18	0	1	0	0	1	0	Χ	Χ	Χ	Χ	64/32	120000h to 12FFFFh	090000h to 097FFFh
a	SA19	0	1	0	0	1	1	Χ	Χ	Χ	Χ	64/32	130000h to 13FFFFh	098000h to 09FFFFh
n k	SA20	0	1	0	1	0	0	Χ	Χ	Χ	Χ	64/32	140000h to 14FFFFh	0A0000h to 0A7FFFh
С	SA21	0	1	0	1	0	1	Χ	Χ	Χ	Χ	64/32	150000h to 15FFFFh	0A8000h to 0AFFFFh
	SA22	0	1	0	1	1	0	Χ	Χ	Χ	Χ	64/32	160000h to 16FFFFh	0B0000h to 0B7FFFh
	SA23	0	1	0	1	1	1	Χ	Χ	Χ	Χ	64/32	170000h to 17FFFFh	0B8000h to 0BFFFFh
	SA24	0	1	1	0	0	0	Χ	Χ	Χ	Χ	64/32	180000h to 18FFFFh	0C0000h to 0C7FFFh
	SA25	0	1	1	0	0	1	Χ	Χ	Χ	Χ	64/32	190000h to 19FFFFh	0C8000h to 0CFFFFh
	SA26	0	1	1	0	1	0	Χ	Χ	Χ	Χ	64/32	1A0000h to 1AFFFFh	0D0000h to 0D7FFFh
	SA27	0	1	1	0	1	1	Χ	Χ	Χ	Χ	64/32	1B0000h to 1BFFFFh	0D8000h to 0DFFFFh
	SA28	0	1	1	1	0	0	Χ	Χ	Χ	Χ	64/32	1C0000h to 1CFFFFh	0E0000h to 0E7FFFh
	SA29	0	1	1	1	0	1	Χ	Χ	Χ	Χ	64/32	1D0000h to 1DFFFFh	0E8000h to 0EFFFFh
	SA30	0	1	1	1	1	0	Χ	Χ	Χ	Χ	64/32	1E0000h to 1EFFFFh	0F0000h to 0F7FFFh
	SA31	0	1	1	1	1	1	Χ	Χ	Χ	Χ	64/32	1F0000h to 1FFFFFh	0F8000h to 0FFFFFh

(Continued)

В					Sec	tor a	addr	ess				Sector		
a	Sec- tor		Bank									size (Kbytes/	(×8) Address range	(×16) Address range
k		A ₂₀	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	A 11	Kwords)	r tuur ooo rungo	7 ta an 333 raings
	SA32	1	0	0	0	0	0	Х	Х	Х	Х	64/32	200000h to 20FFFFh	100000h to 107FFFh
	SA33	1	0	0	0	0	1	Χ	Х	Х	Χ	64/32	210000h to 21FFFFh	108000h to 10FFFFh
	SA34	1	0	0	0	1	0	Х	Х	Х	Х	64/32	220000h to 22FFFFh	110000h to 117FFFh
	SA35	1	0	0	0	1	1	Χ	Х	Χ	Χ	64/32	230000h to 23FFFFh	118000h to 11FFFFh
	SA36	1	0	0	1	0	0	Χ	Χ	Х	Χ	64/32	240000h to 24FFFFh	120000h to 127FFFh
	SA37	1	0	0	1	0	1	Χ	Х	Х	Χ	64/32	250000h to 25FFFFh	128000h to 12FFFFh
	SA38	1	0	0	1	1	0	Χ	Χ	Х	Χ	64/32	260000h to 26FFFFh	130000h to 137FFFh
	SA39	1	0	0	1	1	1	Χ	Χ	Х	Χ	64/32	270000h to 27FFFFh	138000h to 13FFFFh
	SA40	1	0	1	0	0	0	Χ	Χ	Χ	Χ	64/32	280000h to 28FFFFh	140000h to 147FFFh
	SA41	1	0	1	0	0	1	Χ	Χ	Х	Χ	64/32	290000h to 29FFFFh	148000h to 14FFFFh
В	SA42	1	0	1	0	1	0	Χ	Х	Х	Χ	64/32	2A0000h to 2AFFFFh	150000h to 157FFFh
a n	SA43	1	0	1	0	1	1	Х	Х	Х	Χ	64/32	2B0000h to 2BFFFFh	158000h to 15FFFFh
k	SA44	1	0	1	1	0	0	Χ	Х	Х	Χ	64/32	2C0000h to 2CFFFFh	160000h to 167FFFh
В	SA45	1	0	1	1	0	1	Χ	Х	Χ	Χ	64/32	2D0000h to 2DFFFFh	168000h to 16FFFFh
	SA46	1	0	1	1	1	0	Χ	Х	Χ	Χ	64/32	2E0000h to 2EFFFFh	170000h to 177FFFh
	SA47	1	0	1	1	1	1	Χ	Χ	Χ	Χ	64/32	2F0000h to 2FFFFFh	178000h to 17FFFFh
	SA48	1	1	0	0	0	0	Χ	Х	Χ	Χ	64/32	300000h to 30FFFFh	180000h to 187FFFh
	SA49	1	1	0	0	0	1	Х	Х	Х	Χ	64/32	310000h to 31FFFFh	188000h to 18FFFFh
	SA50	1	1	0	0	1	0	Χ	Х	Х	Χ	64/32	320000h to 32FFFFh	190000h to 197FFFh
	SA51	1	1	0	0	1	1	Χ	Х	Χ	Χ	64/32	330000h to 33FFFFh	198000h to 19FFFFh
	SA52	1	1	0	1	0	0	Х	Х	Χ	Χ	64/32	340000h to 34FFFFh	1A0000h to 1A7FFFh
	SA53	1	1	0	1	0	1	Χ	Х	Х	Χ	64/32	350000h to 35FFFFh	1A8000h to 1AFFFFh
	SA54	1	1	0	1	1	0	X	Х	Х	X	64/32	360000h to 36FFFFh	1B0000h to 1B7FFFh
	SA55	1	1	0	1	1	1	Χ	Χ	Х	Χ	64/32	370000h to 37FFFFh	1B8000h to 1BFFFFh

(Continued)

(Continued)

В		Sector address										Sector		
a n	Sec- tor	-	Bank ddres	-								size (Kbytes/	(×8) Address range	(×16) Address range
k		A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	A 11	Kwords)		
	SA56	1	1	1	0	0	0	Χ	Χ	Χ	Χ	64/32	380000h to 38FFFFh	1C0000h to 1C7FFFh
	SA57	1	1	1	0	0	1	Χ	Χ	Χ	Χ	64/32	390000h to 39FFFFh	1C8000h to 1CFFFFh
	SA58	1	1	1	0	1	0	Χ	Χ	Χ	Χ	64/32	3A0000h to 3AFFFFh	1D0000h to 1D7FFFh
	SA59	1	1	1	0	1	1	Χ	Χ	Χ	Χ	64/32	3B0000h to 3BFFFFh	1D8000h to 1DFFFFh
	SA60	1	1	1	1	0	0	Χ	Χ	Χ	Χ	64/32	3C0000h to 3CFFFFh	1E0000h to 1E7FFFh
В	SA61	1	1	1	1	0	1	Χ	Χ	Χ	Χ	64/32	3D0000h to 3DFFFFh	1E8000h to 1EFFFFh
l a	SA62	1	1	1	1	1	0	Χ	Χ	Χ	Χ	64/32	3E0000h to 3EFFFFh	1F0000h to 1F7FFFh
n	SA63	1	1	1	1	1	1	0	0	0	Χ	8/4	3F0000h to 3F1FFFh	1F8000h to 1F8FFFh
k A	SA64	1	1	1	1	1	1	0	0	1	Χ	8/4	3F2000h to 3F3FFFh	1F9000h to 1F9FFFh
	SA65	1	1	1	1	1	1	0	1	0	Χ	8/4	3F4000h to 3F5FFFh	1FA000h to 1FAFFFh
	SA66	1	1	1	1	1	1	0	1	1	Χ	8/4	3F6000h to 3F7FFFh	1FB000h to 1FBFFFh
	SA67	1	1	1	1	1	1	1	0	0	Χ	8/4	3F8000h to 3F9FFFh	1FC000h to 1FCFFFh
	SA68	1	1	1	1	1	1	1	0	1	Χ	8/4	3FA000h to 3FBFFFh	1FD000h to 1FDFFFh
	SA69	1	1	1	1	1	1	1	1	0	Х	8/4	3FC000h to 3FDFFFh	1FE000h to 1FEFFFh
	SA70	1	1	1	1	1	1	1	1	1	Х	8/4	3FE000h to 3FFFFFh	1FF000h to 1FFFFFh

Notes : • The address range is A_{20} : A_{-1} if in byte mode ($\overline{BYTE} = V_{IL}$) . • The address range is A_{20} : A_0 if in word mode ($\overline{BYTE} = V_{IH}$) .

Sector Address Table (MBM29DL320BF)

В		Sector address										Sector		
a n	Sec- tor		Bank Idres									size (Kbytes/	(×8) Address range	(×16) Address range
k		A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	A 11	Kwords)		
	SA70	1	1	1	1	1	1	Χ	Χ	Χ	Χ	64/32	3F0000h to 3FFFFFh	1F8000h to 1FFFFFh
	SA69	1	1	1	1	1	0	Χ	Χ	Χ	Χ	64/32	3E0000h to 3EFFFFh	1F0000h to 1F7FFFh
В	SA68	1	1	1	1	0	1	Χ	Χ	Χ	Χ	64/32	3D0000h to 3DFFFFh	1E8000h to 1EFFFFh
a n	SA67	1	1	1	1	0	0	Χ	Χ	Χ	Χ	64/32	3C0000h to 3CFFFFh	1E0000h to 1E7FFFh
k	SA66	1	1	1	0	1	1	Χ	Χ	Χ	Χ	64/32	3B0000h to 3BFFFFh	1D8000h to 1DFFFFh
D	SA65	1	1	1	0	1	0	Χ	Χ	Χ	Χ	64/32	3A0000h to 3AFFFFh	1D0000h to 1D7FFFh
	SA64	1	1	1	0	0	1	Χ	Χ	Χ	Χ	64/32	390000h to 39FFFFh	1C8000h to 1CFFFFh
	SA63	1	1	1	0	0	0	Χ	Χ	Χ	Χ	64/32	380000h to 38FFFFh	1C0000h to 1C7FFFh
	SA62	1	1	0	1	1	1	Χ	Χ	Χ	Χ	64/32	370000h to 37FFFFh	1B8000h to 1BFFFFh
	SA61	1	1	0	1	1	0	Χ	Χ	Χ	Χ	64/32	360000h to 36FFFFh	1B0000h to 1B7FFFh
	SA60	1	1	0	1	0	1	Χ	Χ	Χ	Χ	64/32	350000h to 35FFFFh	1A8000h to 1AFFFFh
	SA59	1	1	0	1	0	0	Χ	Χ	Χ	Χ	64/32	340000h to 34FFFFh	1A0000h to 1A7FFFh
	SA58	1	1	0	0	1	1	Χ	Χ	Χ	Χ	64/32	330000h to 33FFFFh	198000h to 19FFFFh
	SA57	1	1	0	0	1	0	Χ	Χ	Χ	Χ	64/32	320000h to 32FFFFh	190000h to 197FFFh
	SA56	1	1	0	0	0	1	Χ	Χ	Χ	Χ	64/32	310000h to 31FFFFh	188000h to 18FFFFh
	SA55	1	1	0	0	0	0	Χ	Χ	Χ	Χ	64/32	300000h to 30FFFFh	180000h to 187FFFh
	SA54	1	0	1	1	1	1	Χ	Χ	Χ	Χ	64/32	2F0000h to 2FFFFh	178000h to 17FFFFh
	SA53	1	0	1	1	1	0	Χ	Χ	Χ	Χ	64/32	2E0000h to 2EFFFFh	170000h to 177FFFh
В	SA52	1	0	1	1	0	1	Χ	Χ	Χ	Χ	64/32	2D0000h to 2DFFFFh	168000h to 16FFFFh
a n	SA51	1	0	1	1	0	0	Χ	Χ	Χ	Χ	64/32	2C0000h to 2CFFFFh	160000h to 167FFFh
k	SA50	1	0	1	0	1	1	Χ	Χ	Χ	Χ	64/32	2B0000h to 2BFFFFh	158000h to 15FFFFh
С	SA49	1	0	1	0	1	0	Χ	Χ	Χ	Χ	64/32	2A0000h to 2AFFFh	150000h to 157FFFh
	SA48	1	0	1	0	0	1	Χ	Χ	Χ	Χ	64/32	290000h to 29FFFFh	148000h to 14FFFFh
	SA47	1	0	1	0	0	0	Χ	Χ	Χ	Χ	64/32	280000h to 28FFFFh	140000h to 147FFFh
	SA46	1	0	0	1	1	1	Χ	Χ	Χ	Χ	64/32	270000h to 27FFFFh	138000h to 13FFFFh
	SA45	1	0	0	1	1	0	Χ	Χ	Χ	Χ	64/32	260000h to 26FFFFh	130000h to 137FFFh
	SA44	1	0	0	1	0	1	Χ	Χ	Χ	Χ	64/32	250000h to 25FFFFh	128000h to 12FFFFh
	SA43	1	0	0	1	0	0	Χ	Χ	Χ	Χ	64/32	240000h to 24FFFFh	120000h to 127FFFh
	SA42	1	0	0	0	1	1	Χ	Χ	Χ	Χ	64/32	230000h to 23FFFFh	118000h to 11FFFFh
	SA41	1	0	0	0	1	0	Χ	Χ	Х	Χ	64/32	220000h to 22FFFFh	110000h to 117FFFh
	SA40	1	0	0	0	0	1	Χ	Χ	Х	Χ	64/32	210000h to 21FFFFh	108000h to 10FFFFh
	SA39	1	0	0	0	0	0	Χ	Χ	Х	Χ	64/32	200000h to 20FFFFh	100000h to 107FFFh

(Continued)

В					Sec	tor a	addr	ess				Sector		
a	Sec- tor		Bank									size (Kbytes/	(×8) Address range	(×16) Address range
k	101	A ₂₀	A19	A ₁₈	A 17	A 16	A 15	A 14	A 13	A 12	A 11	Kwords)	Addiess range	Address range
	SA38	0	1	1	1	1	1	Х	Х	Х	Х	64/32	1F0000h to 1FFFFFh	0F8000h to 0FFFFFh
	SA37	0	1	1	1	1	0	Χ	Χ	Χ	Χ	64/32	1E0000h to 1EFFFFh	0F0000h to 0F7FFFh
	SA36	0	1	1	1	0	1	Х	Х	Х	Х	64/32	1D0000h to 1DFFFFh	0E8000h to 0EFFFFh
	SA35	0	1	1	1	0	0	Χ	Х	Χ	Χ	64/32	1C0000h to 1CFFFFh	0E0000h to 0E7FFFh
	SA34	0	1	1	0	1	1	Χ	Х	Χ	Χ	64/32	1B0000h to 1BFFFFh	0D8000h to 0DFFFFh
	SA33	0	1	1	0	1	0	Χ	Х	Х	Χ	64/32	1A0000h to 1AFFFFh	0D0000h to 0D7FFFh
	SA32	0	1	1	0	0	1	Χ	Χ	Х	Χ	64/32	190000h to 19FFFFh	0C8000h to 0CFFFFh
	SA31	0	1	1	0	0	0	Χ	Χ	Х	Χ	64/32	180000h to 18FFFFh	0C0000h to 0C7FFFh
	SA30	0	1	0	1	1	1	Χ	Χ	Χ	Χ	64/32	170000h to 17FFFFh	0B8000h to 0BFFFFh
	SA29	0	1	0	1	1	0	Χ	Χ	Х	Χ	64/32	160000h to 16FFFFh	0B0000h to 0B7FFFh
В	SA28	0	1	0	1	0	1	Χ	Х	Х	Χ	64/32	150000h to 15FFFFh	0A8000h to 0AFFFFh
a	SA27	0	1	0	1	0	0	Х	Х	Х	Χ	64/32	140000h to 14FFFFh	0A0000h to 0A7FFFh
n k	SA26	0	1	0	0	1	1	Χ	Х	Х	Χ	64/32	130000h to 13FFFFh	098000h to 09FFFFh
В	SA25	0	1	0	0	1	0	Χ	Х	Χ	Χ	64/32	120000h to 12FFFFh	090000h to 097FFFh
	SA24	0	1	0	0	0	1	Χ	Х	Χ	Χ	64/32	110000h to 11FFFFh	088000h to 08FFFFh
	SA23	0	1	0	0	0	0	Χ	Χ	Χ	Χ	64/32	100000h to 10FFFFh	080000h to 087FFFh
	SA22	0	0	1	1	1	1	Χ	Х	Χ	Χ	64/32	0F0000h to 0FFFFh	078000h to 07FFFFh
	SA21	0	0	1	1	1	0	Х	Х	Х	Χ	64/32	0E0000h to 0EFFFFh	070000h to 077FFFh
	SA20	0	0	1	1	0	1	Χ	Х	Х	Χ	64/32	0D0000h to 0DFFFFh	068000h to 06FFFFh
	SA19	0	0	1	1	0	0	Χ	Х	Χ	Χ	64/32	0C0000h to 0CFFFFh	060000h to 067FFFh
	SA18	0	0	1	0	1	1	Х	Х	Х	Χ	64/32	0B0000h to 0BFFFFh	058000h to 05FFFFh
	SA17	0	0	1	0	1	0	Χ	Х	Х	Χ	64/32	0A0000h to 0AFFFFh	050000h to 057FFFh
	SA16	0	0	1	0	0	1	X	Х	Х	X	64/32	090000h to 09FFFFh	048000h to 04FFFFh
	SA15	0	0	1	0	0	0	Χ	Х	Х	Χ	64/32	080000h to 08FFFFh	040000h to 047FFFh

(Continued)

(Continued)

В		Sector address										Sector		
a n	Sec- tor	-	Bank ddres	-								size (Kbytes/	(×8) Address range	(×16) Address range
k		A 20	A 19	A 18	A 17 A 10		A 15	A 14	A 13	A 12	A 11	Kwords)		
	SA14	0	0	0	1	1	1	Χ	Χ	Χ	Χ	64/32	070000h to 07FFFh	038000h to 03FFFFh
	SA13	0	0	0	1	1	0	Χ	Х	Χ	Χ	64/32	060000h to 06FFFFh	030000h to 037FFFh
	SA12	0	0	0	1	0	1	Χ	Х	Χ	Χ	64/32	050000h to 05FFFFh	028000h to 02FFFFh
	SA11	0	0	0	1	0	0	Χ	Χ	Χ	Χ	64/32	040000h to 04FFFFh	020000h to 027FFFh
	SA10	0	0	0	0	1	1	Χ	Χ	Χ	Χ	64/32	030000h to 03FFFFh	018000h to 01FFFFh
	SA9	0	0	0	0	1	0	Χ	Х	Χ	Χ	64/32	020000h to 02FFFFh	010000h to 017FFFh
B	SA8	0	0	0	0	0	1	Χ	Χ	Χ	Χ	64/32	010000h to 01FFFFh	008000h to 00FFFFh
n	SA7	0	0	0	0	0	0	1	1	1	Χ	8/4	00E000h to 00FFFFh	007000h to 007FFFh
l k	SA6	0	0	0	0	0	0	1	1	0	Χ	8/4	00C000h to 00DFFFh	006000h to 006FFFh
'	SA5	0	0	0	0	0	0	1	0	1	Χ	8/4	00A000h to 00BFFFh	005000h to 005FFFh
	SA4	0	0	0	0	0	0	1	0	0	Χ	8/4	008000h to 009FFFh	004000h to 004FFFh
	SA3	0	0	0	0	0	0	0	1	1	Χ	8/4	006000h to 007FFFh	003000h to 003FFFh
	SA2	0	0	0	0	0	0	0	1	0	Χ	8/4	004000h to 005FFFh	002000h to 002FFFh
	SA1	0	0	0	0	0	0	0	0	1	Х	8/4	002000h to 003FFFh	001000h to 001FFFh
	SA0	0	0	0	0	0	0	0	0	0	Х	8/4	000000h to 001FFFh	000000h to 000FFFh

Notes : • The address range is A_{20} : A_{-1} if in byte mode ($\overline{BYTE} = V_{IL}$). • The address range is A_{20} : A_0 if in word mode ($\overline{BYTE} = V_{IH}$).

Sector Group Addresses Table (MBM29DL320TF)

Sector group	A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Sectors
SGA0	0	0	0	0	0	0	Х	Х	Х	SA0
					0	1				
SGA1	0	0	0	0	1	0	Х	X	Х	SA1 to SA3
					1	1				
SGA2	0	0	0	1	Х	Х	Х	Х	Х	SA4 to SA7
SGA3	0	0	1	0	Х	Х	Х	Х	Х	SA8 to SA11
SGA4	0	0	1	1	Х	Х	Х	Х	Х	SA12 to SA15
SGA5	0	1	0	0	Х	Х	Х	Х	Х	SA16 to SA19
SGA6	0	1	0	1	Х	Х	Х	Х	Х	SA20 to SA23
SGA7	0	1	1	0	Х	Х	Х	Х	Х	SA24 to SA27
SGA8	0	1	1	1	Х	Х	Х	Х	Х	SA28 to SA31
SGA9	1	0	0	0	Х	Х	Х	Х	Х	SA32 to SA35
SGA10	1	0	0	1	Х	Х	Х	Х	Х	SA36 to SA39
SGA11	1	0	1	0	Х	Х	Х	Х	Х	SA40 to SA43
SGA12	1	0	1	1	Х	Х	Х	Х	Х	SA44 to SA47
SGA13	1	1	0	0	Х	Х	Х	Х	Х	SA48 to SA51
SGA14	1	1	0	1	Х	Х	Х	Х	Х	SA52 to SA55
SGA15	1	1	1	0	Х	Х	Х	Х	Х	SA56 to SA59
					0	0				
SGA16	1	1	1	1	0	1	Х	X	Х	SA60 to SA62
					1	0				
SGA17	1	1	1	1	1	1	0	0	0	SA63
SGA18	1	1	1	1	1	1	0	0	1	SA64
SGA19	1	1	1	1	1	1	0	1	0	SA65
SGA20	1	1	1	1	1	1	0	1	1	SA66
SGA21	1	1	1	1	1	1	1	0	0	SA67
SGA22	1	1	1	1	1	1	1	0	1	SA68
SGA23	1	1	1	1	1	1	1	1	0	SA69
SGA24	1	1	1	1	1	1	1	1	1	SA70

Sector Group Addresses Table (MBM29DL320BF)

Sector group	A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Sectors
SGA0	0	0	0	0	0	0	0	0	0	SA0
SGA1	0	0	0	0	0	0	0	0	1	SA1
SGA2	0	0	0	0	0	0	0	1	0	SA2
SGA3	0	0	0	0	0	0	0	1	1	SA3
SGA4	0	0	0	0	0	0	1	0	0	SA4
SGA5	0	0	0	0	0	0	1	0	1	SA5
SGA6	0	0	0	0	0	0	1	1	0	SA6
SGA7	0	0	0	0	0	0	1	1	1	SA7
					0	1				
SGA8	0	0	0	0	1	0	Х	Х	Х	SA8 to SA10
					1	1				
SGA9	0	0	0	1	Х	Х	Х	Х	Х	SA11 to SA14
SGA10	0	0	1	0	Х	Х	Х	Х	Х	SA15 to SA18
SGA11	0	0	1	1	Х	Х	Х	Χ	Х	SA19 to SA22
SGA12	0	1	0	0	Х	Х	Х	Х	Х	SA23 to SA26
SGA13	0	1	0	1	Х	Х	Х	Х	Х	SA27 to SA30
SGA14	0	1	1	0	Х	Х	Х	Х	Х	SA31 to SA34
SGA15	0	1	1	1	Х	Х	Х	Х	Х	SA35 to SA38
SGA16	1	0	0	0	Х	Х	Х	Х	Х	SA39 to SA42
SGA17	1	0	0	1	Χ	Х	Х	Х	Х	SA43 to SA46
SGA18	1	0	1	0	Х	Х	Х	Х	Х	SA47 to SA50
SGA19	1	0	1	1	Х	Х	Х	Х	Х	SA51 to SA54
SGA20	1	1	0	0	Х	Х	Х	Х	Х	SA55 to SA58
SGA21	1	1	0	1	Х	Х	Х	Х	Х	SA59 to SA62
SGA22	1	1	1	0	Х	Х	Х	Х	Х	SA63 to SA66
					0	0				
SGA23	1	1	1	1	0	1	Х	Χ	X	SA67 to SA69
					1	0				
SGA24	1	1	1	1	1	1	Х	Х	Х	SA70

Common Flash Memory Interface Code Table

Description	A ₆ to A ₀	DQ ₁₅ to DQ ₀
Query-unique ASCII string "QRY"	10h 11h 12h	0051h 0052h 0059h
Primary OEM Command Set 02h : AMD/FJ standard type	13h 14h	0002h 0000h
Address for Primary Extended Table	15h 16h	0040h 0000h
Alternate OEM Command Set (00h = not applicable)	17h 18h	0000h 0000h
Address for Alternate OEM Extended Table	19h 1Ah	0000h 0000h
Vcc Min (write/erase) DQ ₇ -DQ ₄ : 1 V/bit, DQ ₃ -DQ ₀ : 100 mV/bit	1Bh	0027h
Vcc Max (write/erase) DQ ₇ -DQ ₄ : 1 V/bit, DQ ₃ -DQ ₀ : 100 mV/bit	1Ch	0036h
V _{PP} Min voltage	1Dh	0000h
V _{PP} Max voltage	1Eh	0000h
Typical timeout per single byte/word write 2 ^N μs	1Fh	0004h
Typical timeout for Min size buffer write 2 ^N μs	20h	0000h
Typical timeout per individual block erase 2 ^N ms	21h	000Ah
Typical timeout for full chip erase 2 ^N ms	22h	0000h
Max timeout for byte/word write 2 ^N times typical	23h	0005h
Max timeout for buffer write 2 ^N times typical	24h	0000h
Max timeout per individual block erase 2 ^N times typical	25h	0004h
Max timeout for full chip erase 2 ^N times typical	26h	0000h
Device Size = 2 ^N byte	27h	0016h
02h : Supports ×8 and ×16 via BYTE with asynchronous interface.	28h 29h	0002h 0000h
Max number of bytes in multi-byte write = 2 ^N	2Ah 2Bh	0000h 0000h
Number of Erase Block Regions within device	2Ch	0002h
Erase Block Region 1 Information bit 0 to 15 : $y =$ number of sectors bit 16 to 31 : $z =$ size ($z \times 256$ bytes)	2Dh 2Eh 2Fh 30h	0007h 0000h 0020h 0000h
Erase Block Region 2 Information bit 0 to 15 : y = number of sectors bit 16 to 31 : z = size (z × 256 bytes)	31h 32h 33h 34h	003Eh 0000h 0000h 0001h
Query-unique ASCII string "PRI"	40h 41h 42h	0050h 0052h 0049h
Major version number, ASCII	43h	0031h

(Continued)

(Continued)

Description	A ₆ to A ₀	DQ ₁₅ to DQ ₀
Minor version number, ASCII	44h	0033h
Address Sensitive Unlock (DQ ₁ , DQ ₀) 00h = Required, $01h = Not RequiredSilicon Revision Number (DQ7 to DQ2)$	45h	0000h
Erase Suspend 00h = Not Supported 01h = To Read Only 02h = To Read & Write	46h	0002h
Sector Protection 00h = Not Supported X = Number of sectors per group	47h	0001h
Sector Temporary Unprotection 00h = Not Supported 01h = Supported	48h	0001h
Sector Protection Algorithm	49h	0004h
Simultaneous Operation 00h = Not Supported X = Total number of sectors in all banks except Bank 1	4Ah	0038h
Burst Mode Type 00h = Not Supported	4Bh	0000h
Page Mode Type 00h = Not Supported	4Ch	0000h
V _{ACC} (Acceleration) Supply Minimum 00h = Not Supported, DQ ₇ -DQ ₄ : 1 V/bit, DQ ₃ -DQ ₀ : 100 mV/bit	4Dh	0085h
V _{ACC} (Acceleration) Supply Maximum 00h = Not Supported, DQ ₇ -DQ ₄ : 1 V/bit, DQ ₃ -DQ ₀ : 100 mV/bit	4Eh	0095h
Boot Type 02h = MBM29DL320BF 03h = MBM29DL320TF	4Fh	00XXh
Program Suspend 00h = Not Supported 01h = Supported	50h	0001h
Bank Organization 00h = If data at 4Ah is zero. X = Number of Banks	57h	0004h
Bank A Region Information X = Number of sectors in Bank A	58h	000Fh
Bank B Region Information X = Number of sectors in Bank B	59h	0018h
Bank C Region Information X = Number of sectors in Bank C	5Ah	0018h
Bank D Region Information X = Number of sectors in Bank D	5Bh	0008h

■ FUNCTIONAL DESCRIPTION

1. Simultaneous Operation

The device features functions that enable reading of data from one memory bank while a program or erase operation is in progress in the other memory bank (simultaneous operation), in addition to conventional features (read, program, erase, erase-suspend read, and erase-suspend program). The bank can be selected by bank address (A_{20} , A_{19} , A_{18}) with zero latency. The device consists of the following four banks:

Bank A: 8×8 KB and 7×64 KB; Bank B: 24×64 KB; Bank C: 24×64 KB; Bank D: 8×64 KB.

The device can execute simultaneous operations between Bank 1, a bank chosen from among the four banks, and Bank 2, a bank consisting of the three remaining banks. (See "FlexBank™ Architecture Table".) This is what we call a "FlexBank", for example, the rest of banks B, C and D to let the system read while Bank A is in the process of program (or erase) operation. However, the different types of operations for the three banks are impossible, e.g. Bank A writing, Bank B erasing, and Bank C reading out. With this "FlexBank", as described in "Example of Virtual Banks Combination Table", the system gets to select from four combinations of data volume for Bank 1 and Bank 2, which works well to meet the system requirement. The simultaneous operation cannot execute multi-function mode in the same bank. "Simultaneous Operation Table" shows the possible combinations for simultaneous operation.Refer to "8. Bank-to-Bank Read/Write Timing Diagram" in ■TIMING DIAGRAM.

FlexBank™ Architecture Table

Bank		Bank 1		Bank 2					
Splits	Volume	Combination	Volume	Combination					
1	4 Mbit	Bank A	28 Mbit	Bank B, C, D					
2	12 Mbit	Bank B	20 Mbit	Bank A, C, D					
3	12 Mbit	Bank C	20 Mbit	Bank A, B, D					
4	4 Mbit	Bank D	28 Mbit	Bank A, B, C					

Example of Virtual Banks Combination Table

Bank		Baı	nk 1	Bank 2				
Splits	Volume	Combination	Sector Size	Volume	Combination	Sector Size		
					Bank B			
			8×8 Kbyte/4 Kword		+			
1	4 Mbit	Bank A	+	28 Mbit	Bank C	56 × 64 Kbyte/32 Kword		
			7 × 64 Kbyte/32 Kword		+			
					Bank D			
		Bank A	8 × 8 Kbyte/4 Kword		Bank B			
2	8 Mbit	+	+	24 Mbit	+	48 × 64 Kbyte/32 Kword		
		Bank D	15×64 Kbyte/32 Kword		Bank C			
		Bank A	8 × 8 Kbyte/4 Kword		Bank C			
3	16 Mbit	+	+	16 Mbit	+	32 × 64 Kbyte/32 Kword		
		Bank B	31×64 Kbyte/32 Kword		Bank D			

Note: When multiple sector erase over several banks is operated, the system cannot read out of the bank to which a sector being erased belongs. For example, suppose that erasing is taking place at both Bank A and Bank B, neither Bank A nor Bank B is read out (they would output the sequence flag once they were selected.)

Meanwhile the system would get to read from either Bank C or Bank D.

Case	Bank 1 status	Bank 2 status		
1	Read Mode	Read Mode		
2	Read Mode	Autoselect Mode		
3	Read Mode	Program Mode		
4	Read Mode	Erase Mode *		
5	Autoselect Mode	Read Mode		
6	Program Mode	Read Mode		
7	Erase Mode *	Read Mode		

^{*:} By writing erase suspend command on the bank address of sector being erased, the erase operation gets suspended so that it enables reading from or programming the remaining sectors.

Note: Bank 1 and Bank 2 are divided for the sake of convenience at Simultaneous Operation. The Bank consists of 4 banks, Bank A, Bank B, Bank C and Bank D. Bank Address (BA) means to specify each of the Banks.

2. Read Mode

The MBM29DL320TF/BF have two control functions which must be satisfied in order to obtain data at the outputs. $\overline{\text{CE}}$ is the power control and should be used for a device selection. $\overline{\text{OE}}$ is the output control and should be used to gate data to the output pins if a device is selected.

Address access time (tacc) is equal to the delay from stable addresses to valid output data. The chip enable access time (tce) is the delay from stable addresses and stable \overline{CE} to valid data at the output pins. The output enable access time is the delay from the falling edge of \overline{OE} to valid data at the output pins. (Assuming the addresses have been stable for at least tacc-toe time.) When reading out a data without changing addresses after power-up, it is necessary to input hardware reset or to change \overline{CE} pin from "H" or "L"

3. Standby Mode

There are two ways to implement the standby mode on the MBM29DL320TF/BF devices, one using both the CE and RESET pins; the other via the RESET pin only.

When using both pins, a CMOS standby mode is achieved with $\overline{\text{CE}}$ and $\overline{\text{RESET}}$ inputs both held at $V\text{cc} \pm 0.3 \text{ V}$. Under this condition the current consumed is less than 5 μA Max During Embedded Algorithm operation, Vcc active current (Icc2) is required even $\overline{\text{CE}}$ = "H". The device can be read with standard access time (IccE) from either of these standby modes.

When using the $\overline{\text{RESET}}$ pin only, a CMOS standby mode is achieved with $\overline{\text{RESET}}$ input held at $V_{SS} \pm 0.3 \text{ V}$ ($\overline{\text{CE}}$ = "H" or "L") . Under this condition the current is consumed is less than 5 μ A Max Once the $\overline{\text{RESET}}$ pin is taken high, the device requires transfer of wake up time before outputs are valid for read access.

In the standby mode the outputs are in the high impedance state, independent of the $\overline{\text{OE}}$ input.

4. Automatic Sleep Mode

There is a function called automatic sleep mode to restrain power consumption during read-out of MBM29DL320TF/BF data. This mode can be used effectively with an application requested low power consumption such as handy terminals.

To activate this mode, MBM29DL320TF/BF automatically switch themselves to low power mode when MBM29DL320TF/BF addresses remain stable during access fine of 150 ns. It is not necessary to control $\overline{\text{CE}}$, $\overline{\text{WE}}$, and $\overline{\text{OE}}$ on the mode. Under the mode, the current consumed is typically 1 μA (CMOS Level) .

During simultaneous operation, Vcc active current (Icc2) is required.

Since the data are latched during this mode, the data are read-out continuously. If the addresses are changed, the mode is canceled automatically and MBM29DL320TF/BF read-out the data for changed addresses.

5. Output Disable

With the $\overline{\text{OE}}$ input at a logic high level (V_{IH}), output from the devices are disabled. This will cause the output pins to be in a high impedance state.

6. Autoselect

The autoselect mode allows the reading out of a binary code from the devices and will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the devices to be programmed with its corresponding programming algorithm. This mode is functional over the entire temperature range of the devices.

To activate this mode, the programming equipment must force V_{ID} on address pin A_9 . Two identifier bytes may then be sequenced from the devices outputs by toggling address A_0 from V_{IL} to V_{IH} . All addresses are DON'T CARES except A_0 , A_1 , A_2 , A_3 , and A_6 (A_{-1}). (See "MBM29DL320TF/BF User Bus Operations Tables ($\overline{BYTE} = V_{IH}$ and $\overline{BYTE} = V_{IL}$)" in \blacksquare DEVICE BUS OPERATION.)

The manufacturer and device codes may also be read via the command register, for instances when the MBM29DL320TF/BF are erased or programmed in a system without access to high voltage on the A₃ pin. The command sequence is illustrated in "MBM29DL320TF/BF Command Definitions Table" (■DEVICE BUS OPERATION). (Refer to "2. Autoselect Command" in ■COMMAND DIFINITIONS.)

In WORD mode, a read cycle from address 00h returns the manufacturer's code (Fujitsu = 04h). A read cycle at address 01h outputs device code. When 227Eh is output, it indicates that two additional codes, called Extended Device Codes will be required. Therefore the system may continue reading out these Extended Device Codes at addresses of 0Eh and 0Fh. Notice that the above applies to WORD mode; the addresses and codes differ from those of BYTE mode. (Refer to "MBM29DL320TF/BF Sector Group Protection Verify Autoselect Codes Tables" and "MBM29DL320TF/BF Expanded Autoselect Code Tables" in ■DEVICE BUS OPERATION.)

In the case of applying V_{ID} on A_9 , since both Bank 1 and Bank 2 enter Autoselect mode, simultanous operation cannot be executed.

7. Write

Device erasure and programming are accomplished via the command register. The contents of the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device.

The command register itself does not occupy any addressable memory location. The register is a latch used to store the commands, along with the address and data information needed to execute the command. The command register is written by bringing $\overline{\text{WE}}$ to V_{IL} , while $\overline{\text{CE}}$ is at V_{IL} and $\overline{\text{OE}}$ is at V_{IH} . Addresses are latched on the falling edge of $\overline{\text{WE}}$ or $\overline{\text{CE}}$, whichever happens later; while data is latched on the rising edge of $\overline{\text{WE}}$ or $\overline{\text{CE}}$, whichever happens first. Standard microprocessor write timings are used.

8. Sector Group Protection

The MBM29DL320TF/BF feature hardware sector group protection. This feature will disable both program and erase operations in any combination of twenty five sector groups of memory. (See "Sector Group Addresses Tables (MBM29DL320TF/BF)" in ■FLEXIBLE SECTOR-ERASE ARCHITECTURE). The sector group protection feature is enabled using programming equipment at the user's site. The device is shipped with all sector groups unprotected.

To activate this mode, the programming equipment must force V_{ID} on address pin A_9 and control pin \overline{OE} , (suggest $V_{ID} = 11.5 \text{ V}$), $\overline{CE} = V_{IL}$ and $A_6 = A_3 = A_2 = A_0 = V_{IL}$, $A_1 = V_{IH}$. The sector group addresses (A_{20} , A_{19} , A_{18} , A_{17} , A_{16} , A_{15} , A_{14} , A_{13} , and A_{12}) should be set to the sector to be protected. "Sector Address Tables (MBM29DL320TF/BF)" in FLEXIBLE SECTOR-ERASE ARCHITECTURE define the sector address for each of the seventy one (71) individual sectors, and "Sector Group Addresses Tables (MBM29DL320TF/BF)" in FLEXIBLE SECTOR-ERASE ARCHITECTURE define the sector group address for each of the twenty five (25) individual group sectors. Programming of the protection circuitry begins on the falling edge of the \overline{WE} pulse and is terminated with the rising edge of the same. Sector group addresses must be held constant during the \overline{WE} pulse. See "15. Sector Group Protection Timing Diagram" in TIMING DIAGRAM and "5. Sector Group Protection Algorithm" in FLOW CHART for sector group protection waveforms and algorithm.

To verify programming of the protection circuitry, the programming equipment must force V_{ID} on address pin A_9 with \overline{CE} and \overline{OE} at V_{IL} and \overline{WE} at V_{IH} . Scanning the sector group addresses (A_{20} , A_{19} , A_{18} , A_{17} , A_{16} , A_{15} , A_{14} , A_{13} , and A_{12}) while (A_6 , A_3 , A_2 , A_1 , A_0) = (0, 0, 0, 1, 0) will produce a logic "1" code at device output DQ₀ for a protected sector. Otherwise the device will produce "0" for unprotected sector. In this mode, the lower order addresses, except for A_6 , A_1 , and A_0 are DON'T CARES. Address locations with $A_1 = V_{IL}$ are reserved for Autoselect manufacturer and device codes. A_{-1} requires to apply to V_{IL} on byte mode.

It is also possible to determine if a sector group is protected in the system by writing an Autoselect command. Performing a read operation at the address location XX02h, where the higher order addresses (A₂₀, A₁ٶ, A₁ء, A₁ء, A₁₅, A₁₅, A₁₅, A₁₃, and A₁₂) are the desired sector group address will produce a logic "1" at DQ₀ for a protected sector group. See "MBM29DL320TF/BF Sector Group Protection Verify Autoselect Codes Tables" and "MBM29DL320TF/BF Expanded Autoselect Code Tables" in ■DEVICE BUS OPERATION for Autoselect codes.

9. Temporary Sector Group Unprotection

This feature allows temporary unprotection of previously protected sector groups of the MBM29DL320TF/BF devices in order to change data. The Sector Group Unprotection mode is activated by setting the \overline{RESET} pin to high voltage (V_{ID}). During this mode, formerly protected sector groups can be programmed or erased by selecting the sector group addresses. Once the V_{ID} is taken away from the \overline{RESET} pin, all the previously protected sector groups will be protected again. Refer to "16. Temporary Sector Group Unprotection Timing Diagram" in \blacksquare TIMING DIAGRAM and "6. Temporary Sector Group Unprotection Algorithm" in \blacksquare FLOW CHART.

10. RESET

Hardware Reset

The MBM29DL320TF/BF devices may be reset by driving the RESET pin to V_{IL}. The RESET pin has a pulse requirement and has to be kept low (V_{IL}) for at least "t_{RP}" in order to properly reset the internal state machine. Any operation in the process of being executed will be terminated and the internal state machine will be reset to the read mode "t_{READY}" after the RESET pin is driven low. Furthermore, once the RESET pin goes high, the devices require an additional "t_{RH}" before it will allow read access. When the RESET pin is low, the devices will be in the standby mode for the duration of the pulse and all the data output pins will be tri-stated. If a hardware reset occurs during a program or erase operation, the data at that particular location will be corrupted. Please note that the RY/BY output signal should be ignored during the RESET pulse. See "11. RESET, RY/BY Timing Diagram" in ■TIMING DIAGRAM for the timing diagram. Refer to "9. Temporary Sector Group Unprotection" for additional functionality.

11. Byte/Word Configuration

The BYTE pin selects the byte (8-bit) mode or word (16-bit) mode for the MBM29DL320TF/BF devices. When this pin is driven high, the devices operate in the word (16-bit) mode. The data is read and programmed at DQ₀ to DQ₁₅. When this pin is driven low, the devices operate in byte (8-bit) mode. Under this mode, the DQ₁₅/A₋₁ pin becomes the lowest address bit and DQ₈ to DQ₁₄ bits are tri-stated. However, the command bus cycle is always an 8-bit operation and hence commands are written at DQ₀ to DQ₇ and the DQ₈ to DQ₁₅ bits are ignored. Refer

to "12. Timing Diagram for Word Mode Configuration", "13. Timing Diagram for Byte Mode Configuration" and "14. BYTE Timing Diagram for Write Operations" in ■TIMING DIAGRAM for the timing diagram.

12. Boot Block Sector Protection

The Write Protection function provides a hardware method of protecting certain boot sectors without using V_{ID} . This function is one of two provided by the \overline{WP}/ACC pin.

If the system asserts V_{IL} on the $\overline{\text{WP}}/\text{ACC}$ pin, the device disables program and erase functions in the two "outermost" 8 K byte boot sectors independently of whether those sectors were protected or unprotected using the method described in "Sector Group Protection". The two outermost 8 K byte boot sectors are the two sectors containing the lowest addresses in a bottom-boot-configured device, or the two sectors containing the highest addresses in a top-boot-configured device.

(MBM29DL320TF: SA69 and SA70, MBM29DL320BF: SA0 and SA1)

If the system asserts V_H on the \overline{WP}/ACC pin, the device reverts to whether the two outermost 8 K byte boot sectors were last set to be protected or unprotected. That is, sector protection or unprotection for these two sectors depends on whether they were last protected or unprotected using the method described in "Sector Group Protection".

13. Accelerated Program Operation

MBM29DL320TF/BF offers accelerated program operation which enables the programming in high speed. If the system asserts Vacc to the \overline{WP}/ACC pin, the device automatically enters the acceleration mode and the time required for program operation will reduce to about 60%. This function is primarily intended to allow high speed program, so caution is needed as the sector group will temporarily be unprotected.

The system would use a fact program command sequence when programming during acceleration mode. Set command to fast mode and reset command from fast mode are not necessary. When the device enters the acceleration mode, the device automatically set to fast mode. Therefore, the present sequence could be used for programming and detection of completion during acceleration mode.

Removing Vacc from the WP/ACC pin returns the device to normal operation. Do not remove Vacc from WP/ACC pin while programming. See "18. Accelerated Program Timing Diagram" in ■TIMING DIAGRAM.

■ COMMAND DEFINITIONS

Device operations are selected by writing specific address and data sequences into the command register. Some commands are required Bank Address (BA) input. When command sequences are inputted to bank being read, the commands have priority than reading. "MBM29DL320TF/BF Command Definitions Table" in ■DEVICE BUS OPERATION defines the valid register command sequences. Note that the Erase Suspend (B0h) and Erase Resume (30h) commands are valid only while the Sector Erase operation is in progress. Also the Program Suspend (B0h) and Program Resume (30h) commands are valid only while the Program operation is in progress. Moreover both Read/Reset commands are functionally equivalent, resetting the device to the read mode. Please note that commands are always written at DQ7 to DQ₀ and DQ₀ to DQ₁₅ bits are ignored.

1. Read/Reset Command

In order to return from Autoselect mode or Exceeded Timing Limits ($DQ_5 = 1$) to Read/Reset mode, the Read/Reset operation is initiated by writing the Read/Reset command sequence into the command register. Microprocessor read cycles retrieve array data from the memory. The devices remain enabled for reads until the command register contents are altered.

The devices will automatically power-up in the Read/Reset state. In this case, a command sequence is not required to read data. Standard microprocessor read cycles will retrieve array data. This default value ensures that no spurious alteration of the memory content occurs during the power transition. Refer to the AC Characteristics and waveforms for the specific timing parameters.

2. Autoselect Command

Flash memories are intended for use in applications where the local CPU alters memory contents. As such, manufacture and device codes must be accessible while the devices reside in the target system. PROM programmers typically access the signature codes by raising A_{θ} to a high voltage. However, multiplexing high voltage onto the address lines is not generally desired system design practice.

The device contains an Autoselect command operation to supplement traditional PROM programming methodology. The operation is initiated by writing the Autoselect command sequence into the command register.

The Autoselect command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle that contains the bank address (BA) and the Autoselect command. Then the manufacture and device codes can be read from the bank, and an actual data of memory cell can be read from the another bank.

Following the command write, in WORD mode, a read cycle from address (BA) 00h returns the manufacturer's code (Fujitsu = 04h). And a read cycle at address (BA) 01h outputs device code. When 227Eh was output, this indicates that two additional codes, called Extended Device Codes will be required. Therefore the system may continue reading out these Extended Device Codes at the address of (BA) 0Eh, as well as at (BA) 0Fh. Notice that the above applies to WORD mode. The addresses and codes differ from those of BYTE mode. (Refer to "MBM29DL320TF/BF Sector Group Protection Verify Autoselect Codes Tables" and "MBM29DL320TF/BF Expanded Autoselect Code Tables" in ■DEVICE BUS OPERATION.)

All manufacturer and device codes will exhibit odd parity with DQ₇ defined as the parity bit. Sector state (protection or unprotection) will be informed by address (BA) 02h for ×16 ((BA) 04h for ×8). Scanning the sector group addresses (A₂₀, A₁₉, A₁₈, A₁₇, A₁₆, A₁₅, A₁₄, A₁₃, and A₁₂) while (A₆, A₃, A₂, A₁, A₀) = (0, 0, 0, 1, 0) will produce a logic "1" at device output DQ₀ for a protected sector group. The programming verification should be performed by verify sector group protection on the protected sector. (See "MBM29DL320TF/BF Sector Group Protection Verify Autoselect Codes Tables" and "MBM29DL320TF/BF Expanded Autoselect Code Tables" in ■DEVICE BUS OPERATION.)

The manufacture and device codes can be allowed reading from selected bank. To read the manufacture and device codes and sector protection status from non-selected bank, it is necessary to write Read/Reset command sequence into the register and then Autoselect command should be written into the bank to be read.

If the software (program code) for Autoselect command is stored into the Flash memory, the device and manufacture codes should be read from the other bank where is not contain the software.

To terminate the operation, it is necessary to write the Read/Reset command sequence into the register, and also to write the Autoselect command during the operation, execute it after writing Read/Reset command sequence.

3. Byte/Word Programming

The devices are programmed on a byte-by-byte (or word-by-word) basis. Programming is a four bus cycle operation. There are two "unlock" write cycles. These are followed by the program set-up command and data write cycles. Addresses are latched on the falling edge of \overline{CE} or \overline{WE} , whichever happens later and the data is latched on the rising edge of \overline{CE} or \overline{WE} , whichever happens first. The rising edge of \overline{CE} or \overline{WE} (whichever happens first) begins programming. Upon executing the Embedded Program Algorithm command sequence, the system is not required to provide further controls or timings. The device will automatically provide adequate internally generated program pulses and verify the programmed cell margin.

The system can determine the status of the program operation by using DQ_7 (\overline{Data} Polling), DQ_6 (Toggle Bit), or RY/ \overline{BY} . The \overline{Data} Polling and Toggle Bit must be performed at the memory location which is being programmed.

The automatic programming operation is completed when the data on DQ_7 is equivalent to data written to this bit at which time the devices return to the read mode and addresses are no longer latched. (See "Hardware Sequence Flags Table".) Therefore, the devices require that a valid address to the devices be supplied by the system at this particular instance. Hence, \overline{Data} Polling must be performed at the memory location which is being programmed.

If hardware reset occurs during the programming operation, it is impossible to guarantee the data being written.

Programming is allowed in any sequence and across sector boundaries. Beware that a data "0" cannot be programmed back to a "1". Attempting to do so may either hang up the device or result in an apparent success according to the data polling algorithm but a read from Read/Reset mode will show that the data is still "0". Only erase operations can convert "0"s to "1"s.

"1. Embedded Program™ Algorithm" in ■FLOW CHART illustrates the Embedded Program™ Algorithm using typical command strings and bus operations.

4. Program Suspend/Resume

The Program Suspend command allows the system to interrupt a program operation so that data can be read from any address. Writing the Program Suspend command (B0h) during the embedded Program operation immediately suspends the programming. The Program Suspend command may also be issued during a programming operation while an erase is suspended. The bank addresses of sector being programmed should be set when writing the Program Suspend command.

When the Program Suspend command is written during a programming process, the device halts the program operation within 1 μ s and updates the status bits.

After the program operation has been suspended, the system can read data from any address. The data at program-suspended address is not valid. Normal read timing and command definitions apply.

After the Program Resume command (30h) is written, the device reverts to programming. The bank addresses of sectors being suspended should be set when writing the Program Resume command. The system can determine the program operation status using the DQ_7 or DQ_6 status bits, just as in the standard program operation. See "Write Operation Status" for more information.

The system also writes Autoselect command sequence in the Program Suspend mode. The device allows reading autoselect codes at the addresses within programming sectors, since the codes are not stored in the mamory. When the device exits from the Autoselect mode, the device reverts to the Program Suspend mode, and is ready for another valid operation. See "Autoselect Command Sequence" for more information.

The system must write the Program Resume command (address bits are "Bank Address") to exit from the Program Suspend mode and continue programming operation. Further writes of the Resume command are ignored. Another Program Suspend command can be written after the device resumes programming.

5. Chip Erase

Chip erase is a six bus cycle operation. There are two "unlock" write cycles. These are followed by writing the "set-up" command. Two more "unlock" write cycles are then followed by the chip erase command.

Chip erase does not require the user to program the device prior to erase. Upon executing the Embedded Erase Algorithm command sequence the devices will automatically program and verify the entire memory for an all zero data pattern prior to electrical erase (Preprogram function) . The system is not required to provide any controls or timings during these operations.

The system can determine the status of the erase operation by using DQ_7 (\overline{Data} Polling), DQ_6 (Toggle Bit), or RY/BY. The chip erase begins on the rising edge of the last \overline{CE} or \overline{WE} , whichever happens first in the command sequence and terminates when the data on DQ_7 is "1" (See Write Operation Status section.) at which time the device returns to read the mode.

Chip Erase Time = Sector Erase Time × All sectors + Chip Program Time (Preprogramming)

"2. Embedded Erase™ Algorithm" in ■FLOW CHART illustrates the Embedded Erase™ Algorithm using typical command strings and bus operations.

6. Sector Erase

Sector erase is a six bus cycle operation. There are two "unlock" write cycles. These are followed by writing the "set-up" command. Two more "unlock" write cycles are then followed by the Sector Erase command. The sector address (any address location within the desired sector) is latched on the falling edge of \overline{CE} or \overline{WE} whichever happens later, while the command (Data = 30h) is latched on the rising edge of \overline{CE} or \overline{WE} which happens first. After time-out of "trow" from the rising edge of the last sector erase command, the sector erase operation will begin.

Multiple sectors may be erased concurrently by writing the six bus cycle operations on "MBM29DL320TF/BF Command Definitions Table" in \blacksquare DEVICE BUS OPERATION. This sequence is followed with writes of the Sector Erase command to addresses in other sectors desired to be concurrently erased. The time between writes must be less than " t_{TOW} " otherwise that command will not be accepted and erasure will start. It is recommended that processor interrupts be disabled during this time to guarantee this condition. The interrupts can be re-enabled after the last Sector Erase command is written. A time-out of " t_{TOW} " from the rising edge of last \overline{CE} or \overline{WE} whichever happens first will initiate the execution of the Sector Erase command (s) . If another falling edge of \overline{CE} or \overline{WE} , whichever happens first occurs within the " t_{TOW} " time-out window the timer is reset. (Monitor DQ3 to determine if the sector erase timer window is still open, see "16. DQ3 Sector Erase Timer".) Resetting the devices once execution has begun will corrupt the data in the sector. In that case, restart the erase on those sectors and allow them to complete. (Refer to "12. Write Operation Status" for Sector Erase Timer operation.) Loading the sector erase buffer may be done in any sequence and with any number of sectors (0 to 38) .

Sector erase does not require the user to program the devices prior to erase. The devices automatically program all memory locations in the sector (s) to be erased prior to electrical erase (Preprogram function). When erasing a sector or sectors the remaining unselected sectors are not affected. The system is not required to provide any controls or timings during these operations.

The system can determine the status of the erase operation by using DQ_7 (\overline{Data} Polling), DQ_6 (Toggle Bit), or RY/ \overline{BY} .

The sector erase begins after the " t_{TOW} " time out from the rising edge of \overline{CE} or \overline{WE} whichever happens first for the last sector erase command pulse and terminates when the data on DQ_7 is "1" (See "12. Write Operation Status".) at which time the devices return to the read mode. \overline{Data} polling and Toggle Bit must be performed at an address within any of the sectors being erased.

Multiple Sector Erase Time = [Sector Erase Time + Sector Program Time (Preprogramming)] \times Number of Sector Erase

In case of multiple sector erase across bank boundaries, a read from bank (read-while-erase) can not perform.

"2. Embedded Erase™ Algorithm" in ■FLOW CHART illustrates the Embedded Erase™ Algorithm using typical command strings and bus operations.

7. Erase Suspend/Resume

The Erase Suspend command allows the user to interrupt a Sector Erase operation and then perform data reads from or programs to a sector not being erased. This command is applicable ONLY during the Sector Erase operation which includes the time-out period for sector erase. Writing the Erase Suspend command (B0h) during the Sector Erase time-out results in immediate termination of the time-out period and suspension of the erase operation.

Writing the Erase Resume command (30h) resumes the erase operation. The bank addresses of sector being erasing or suspending should be set when writing the Erase Suspend or Erase Resume command.

When the Erase Suspend command is written during the Sector Erase operation, the device will take a maximum of " t_{SPD} " to suspend the erase operation. When the devices have entered the erase-suspended mode, the RY/\overline{BY} output pin will be at High-Z and the DQ_7 bit will be at logic "1", and DQ_6 will stop toggling. The user must use the address of the erasing sector for reading DQ_6 and DQ_7 to determine if the erase operation has been suspended. Further writes of the Erase Suspend command are ignored.

When the erase operation has been suspended, the devices default to the erase-suspend-read mode. Reading data in this mode is the same as reading from the standard read mode except that the data must be read from sectors that have not been erase-suspended. Successively reading from the erase-suspended sector while the device is in the erase-suspend-read mode will cause DQ₂ to toggle. (See "17. DQ₂".)

After entering the erase-suspend-read mode, the user can program the device by writing the appropriate command sequence for Program. This program mode is known as the erase-suspend-program mode. Again, programming in this mode is the same as programming in the regular Program mode except that the data must be programmed to sectors that are not erase-suspended. Successively reading from the erase-suspended sector while the devices are in the erase-suspend-program mode will cause DQ_2 to toggle. The end of the erase-suspended Program operation is detected by the RY/ \overline{BY} output pin, \overline{Data} polling of DQ_7 or by the Toggle Bit I (DQ_6) which is the same as the regular Program operation. Note that DQ_7 must be read from the Program address while DQ_6 can be read from any address within bank being erase-suspended.

To resume the operation of Sector Erase, the Resume command (30h) should be written to the bank being erase suspended. Any further writes of the Resume command at this point will be ignored. Another Erase Suspend command can be written after the chip has resumed erasing.

8. Extended Command

(1) Fast Mode

MBM29DL320TF/BF has Fast Mode function. This mode dispenses with the initial two unclock cycles required in the standard program command sequence by writing Fast Mode command into the command register. In this mode, the required bus cycle for programming is two cycles instead of four bus cycles in standard program command. (Do not write erase command in this mode.) The read operation is also executed after exiting this mode. To exit this mode, it is necessary to write Fast Mode Reset command into the command register. The first cycle must contain the bank address. (Refer to "8. Embedded ProgramTM Algorithm for Fast Mode" in \blacksquare FLOW CHART.) The Vcc active current is required even $\overline{CE} = VIH$ during Fast Mode.

(2) Fast Programming

During Fast Mode, the programming can be executed with two bus cycles operation. The Embedded Program Algorithm is executed by writing program set-up command (A0h) and data write cycles (PA/PD) . (Refer to "8. Embedded Program™ Algorithm for Fast Mode" in ■FLOW CHART.)

(3) Extended Sector Group Protection

In addition to normal sector group protection, the MBM29DL320TF/BF has Extended Sector Group Protection as extended function. This function enables to protect sector group by forcing V_{ID} on \overline{RESET} pin and write a command sequence. Unlike conventional procedure, it is not necessary to force V_{ID} and control timing for control pins. The only \overline{RESET} pin requires V_{ID} for sector group protection in this mode. The extended sector group

protection requires V_{ID} on \overline{RESET} pin. With this condition, the operation is initiated by writing the set-up command (60h) into the command register. Then, the sector group addresses pins (A₂₀, A₁₉, A₁₈, A₁₇, A₁₆, A₁₅, A₁₄, A₁₃ and A₁₂) and (A₆, A₃, A₂, A₁, A₀) = (0, 0, 0, 1, 0) should be set to the sector group to be protected (recommend to set V_{IL} for the other addresses pins) , and write extended sector group protection command (60h) . A sector group is typically protected in 250 μ s. To verify programming of the protection circuitry, the sector group addresses pins (A₂₀, A₁₉, A₁₈, A₁₇, A₁₆, A₁₅, A₁₄, A₁₃ and A₁₂) and (A₆, A₃, A₂, A₁, A₀) = (0, 0, 0, 1, 0) should be set and write a command (40h) . Following the command write, a logic "1" at device output DQ₀ will produce for protected sector in the read operation. If the output data is logic "0", please repeat to write extended sector group protection command (60h) again. To terminate the operation, it is necessary to set \overline{RESET} pin to V_{IH} . (Refer to "17. Extended Sector Group Protection Timing Diagram" in \blacksquare TIMING DIAGRAM and "7. Extended Sector Group Protection Algorithm" in \blacksquare FLOW CHART.)

(4) CFI (Common Flash Memory Interface)

The CFI (Common Flash Memory Interface) specification outlines device and host system software interrogation handshake which allows specific vendor-specified software algorithms to be used for entire families of devices. This allows device-independent, JEDEC ID-independent, and forward-and backward-compatible software support for the specified flash device families. Refer to Common Flash memory Interface code.

The operation is initiated by writing the query command (98h) into the command register. The bank address should be set when writing this command. Then the device information can be read from the bank, and an actual data of memory cell be read from the another bank. Following the command write, a read cycle from specific address retrieves device information. Please note that output data of upper byte (DQ₁₅ to DQ₃) is "0" in word mode (16 bit) read. Refer to the Common Flash memory Interface code table. To terminate operation, it is necessary to write the read/reset command sequence into the register. (See "Common Flash Memory Interface Code Table" in ■FLEXIBLE SECTOR-ERASE ARCHITECTURE.)

9. Hidden ROM (Hi-ROM) Region

The Hi-ROM feature provides a Flash memory region that the system may access through a new command sequence. This is primarily intended for customers who wish to use an Electronic Serial Number (ESN) in the device with the ESN protected against modification. Once the Hi-ROM region is protected, any further modification of that region is impossible. This ensures the security of the ESN once the product is shipped to the field.

The Hi-ROM region is 256 bytes in length and is stored at the same address of the 8 KB sectors. The MBM29DL320TF occupies the address of the byte mode 3FFF00h to 3FFFFFh (word mode 1FFF80h to 1FFFFFh) and the MBM29DL320BF type occupies the address of the byte mode 000000h to 0000FFh (word mode 000000h to 00007Fh). After the system has written the Enter Hi-ROM command sequence, the system may read the Hi-ROM region by using the addresses normally occupied by the boot sectors. That is, the device sends all commands that would normally be sent to the boot sectors to the Hi-ROM region. This mode of operation continues until the system issues the Exit Hi-ROM command sequence, or until power is removed from the device. On power-up, or following a hardware reset, the device reverts to sending commands to the boot sectors.

10. Hidden ROM (Hi-ROM) Entry Command

The device has a Hidden ROM area with one time protect function. This area is to enter the security code and to unable the change of the code once set. Programming is allowed in this area until it is protected. However, once it gets protected, it is impossible to unprotect. Therefore, extreme caution is required.

The hidden ROM area is 256 bytes. This area is normally the "outermost" 8 Kbyte boot block area in Bank 1. Therefore, write the Hidden ROM entry command sequence to enter the Hidden ROM area. It is called Hidden ROM mode when the Hidden ROM area appears.

Sectors other than the boot block area SA0 can be read during Hidden ROM mode. Read/program of the Hidden ROM area is possible during Hidden ROM mode. Write the Hidden ROM reset command sequence to exit the Hidden ROM mode. The bank address of the Hidden ROM should be set on the third cycle of this reset command sequence.

In Hidden ROM mode, the simultaneous operation cannot be executed multi-function mode between the Hidden ROM area and the Bank 1.

11. Hidden ROM (Hi-ROM) Program Command

To program the data to the Hidden ROM area, write the Hidden ROM program command sequence during Hidden ROM mode. This command is the same as the usual program command, except that it needs to write the command during Hidden ROM mode. Therefore the detection of completion method is the same as in the past, using the DQ_7 data pooling, DQ_6 toggle bit and RY/\overline{BY} pin. You should pay attention to the address to be programmed. If an address not in the Hidden ROM area is selected, the previous data will be deleted.

12. Hidden ROM (Hi-ROM) Protect Command

There are two methods to protect the Hidden ROM area. One is to write the sector group protect setup command (60h) , set the sector address in the Hidden ROM area and $(A_6, A_3, A_2, A_1, A_0) = (0, 0, 0, 1, 0)$, and write the sector group protect command (60h) during the Hidden ROM mode. The same command sequence may be used because it is the same as the extension sector group protect in the past, except that it is in the Hidden ROM mode and does not apply high voltage to the \overline{RESET} pin. Please refer to "7. Extended Command (3) Extended Sector Group Protection" for details of extension sector group protect setting.

The other method is to apply high voltage (V_{ID}) to A_9 and \overline{OE} , set the sector address in the Hidden ROM area and (A_6 , A_3 , A_2 , A_1 , A_0) = (0, 0, 0, 1, 0), and apply the write pulse during the Hidden ROM mode. To verify the protect circuit, apply high voltage (V_{ID}) to A_9 , specify (A_6 , A_3 , A_2 , A_1 , A_0) = (0, 0, 0, 1, 0) and the sector address in the Hidden ROM area, and read. When "1" appears on DQ₀, the protect setting is completed. "0" will appear on DQ₀ if it is not protected. Apply write pulse again. The same command sequence could be used for the above method because other than the Hidden ROM mode, it is the same as the sector group protect previously mentioned. Refer to "8. Secor Group Protection" in **EFUNCTIONAL DESCRIPTION** for details of the sector group protect setting.

Take note that other sector groups will be affected if an address other than those for the Hidden ROM area is selected for the sector group address, so please be careful. Pay close attention that once it is protected, protection CANNOT BE CANCELLED.

13. Write Operation Status

Detailed in "Hardware Sequence Flags Table" are all the status flags that can determine the status of the bank for the current mode operation. The read operation from the bank that does not operate Embedded Algorithm returns a data of memory cell. These bits offer a method for determining whether a Embedded Algorithm is completed properly. The information on DQ_2 is address sensitive. This means that if an address from an erasing sector is consecutively read, then the DQ_2 bit will toggle. However, DQ_2 will not toggle if an address from a non-erasing sector is consecutively read. This allows the user to determine which sectors are erasing and which are not.

The status flag is not output from bank (non-busy bank) not executing Embedded Algorithm. For example, there is bank (busy bank) which is now executing Embedded Algorithm. When the read sequence is [1] <busy bank>, [2] <non-busy bank>, [3] <busy bank>, the DQ6 is toggling in the case of [1] and [3]. In case of [2], the data of memory cell is outputted. In the erase-suspend read mode with the same read sequence, DQ6 will not be toggled in the [1] and [3].

In the erase suspend read mode, DQ₂ is toggled in the [1] and [3]. In case of [2], the data of memory cell is outputted.

Hardware Sequence Flags Table

Status			DQ ₇	DQ ₆	DQ₅	DQ ₃	DQ ₂
In Progress	Embedded Program Algorithm		DQ ₇	Toggle	0	0	1
	Embedded Erase Algorithm		0	Toggle	0	1	Toggle *1
	Program Suspended Mode	Program Suspend Read (Program Suspended Sector)	Data	Data	Data	Data	Data
		Program Suspend Read (Non-Program Suspended Sector)	Data	Data	Data	Data	Data
	Erase Suspended Mode	Erase Suspend Read (Erase Suspended Sector)	1	1	0	0	Toggle
		Erase Suspend Read (Non-Erase Suspended Sector)	Data	Data	Data	Data	Data
		Erase Suspend Program (Non-Erase Suspended Sector)	DQ ₇	Toggle	0	0	1 *2
Exceeded Time Limits	Embedded Program Algorithm		DQ ₇	Toggle	1	0	1
	Embedded Erase Algorithm		0	Toggle	1	1	N/A
	Erase Suspended Mode	Erase Suspend Program (Non-Erase Suspended Sector)	DQ 7	Toggle	1	0	N/A

^{*1:} Successive reads from the erasing or erase-suspend sector will cause DQ2 to toggle.

Notes: • DQ₀ and DQ₁ are reserve pins for future use.

• DQ4 is limited to Fujitsu internal use.

14. DQ7

Data Polling

The device features Data Polling as a method to indicate to the host that the Embedded Algorithms are in progress or completed. During the Embedded Program Algorithm an attempt to read the devices will produce the complement of the data last written to DQ₇. Upon completion of the Embedded Program Algorithm, an attempt to read the device will produce the true data last written to DQ₇. During the Embedded Erase Algorithm, an attempt to read the device will produce a "0" at the DQ₇ output. Upon completion of the Embedded Erase Algorithm an attempt to read the device will produce a "1" at the DQ₇ output. The flowchart for Data Polling (DQ₇) is shown in "3. Data Polling Algorithm" in ■FLOW CHART.

For programming, the Data Polling is valid after the rising edge of fourth write pulse in the four write pulse sequence.

For chip erase and sector erase, the Data Polling is valid after the rising edge of the sixth write pulse in the six write pulse sequence. Data Polling must be performed at sector address within any of the sectors being erased and not a protected sector. Otherwise the status may not be valid.

If a program address falls within a protected sector, $\overline{\text{Data}}$ Polling on DQ₇ is active for approximately 1 µs, then that bank returns to the read mode. After an erase command sequence is written, if all sectors selected for erasing are protected, $\overline{\text{Data}}$ Polling on DQ₇ is active for approximately 400 µs, then the bank returns to read mode.

Once the Embedded Algorithm operation is close to being completed, the MBM29DL320TF/BF data pins (DQ_7) may change asynchronously while the output enable (\overline{OE}) is asserted low. This means that the devices are driving status information on DQ_7 at one instant of time and then that byte's valid data at the next instant of time. Depending on when the system samples the DQ_7 output, it may read the status or valid data. Even if the device

^{*2:} Reading from non-erase suspend sector address will indicate logic "1" at the DQ2 bit.

has completed the Embedded Algorithm operation and DQ_7 has a valid data, the data outputs on DQ_6 to DQ_0 may be still invalid. The valid data on DQ_7 to DQ_0 will be read on the successive read attempts.

The Data Polling feature is only active during the Embedded Programming Algorithm, Embedded Erase Algorithm or sector erase time-out. (See "Hardware Sequence Flags Table".)

See "6. Data Polling during Embedded Algorithm Operation Timing Diagram" in ■TIMING DIAGRAM for the Data Polling timing specifications and diagrams.

15. DQ6

Toggle Bit I

The device also features the "Toggle Bit I" as a method to indicate to the host system that the Embedded Algorithms are in progress or completed.

During an Embedded Program or Erase Algorithm cycle, successive attempts to read (\overline{OE} toggling) data from the devices will result in DQ $_6$ toggling between one and zero. Once the Embedded Program or Erase Algorithm cycle is completed, DQ $_6$ will stop toggling and valid data will be read on the next successive attempts. During programming, the Toggle Bit I is valid after the rising edge of the fourth write pulse in the four write pulse sequence. For chip erase and sector erase, the Toggle Bit I is valid after the rising edge of the sixth write pulse in the six write pulse sequence. The Toggle Bit I is active during the sector time out.

In programming, if the sector being written to is protected, the toggle bit will toggle for about 1 μ s and then stop toggling without the data having changed. In erase, the devices will erase all the selected sectors except for the ones that are protected. If all selected sectors are protected, the chip will toggle the toggle bit for about 400 μ s and then drop back into read mode, having changed none of the data.

Either $\overline{\text{CE}}$ or $\overline{\text{OE}}$ toggling will cause the DQ6 to toggle.

The system can use DQ_6 to determine whether a sector is actively erasing or is erase-suspended. When a bank is actively erasing (that is, the Embedded Erase Algorithm is in progress), DQ_6 toggles. When a bank enters the Erase Suspend mode, DQ_6 stops toggling. Successive read cycles during the erase-suspend-program cause DQ_6 to toggle.

To operate toggle bit function properly, $\overline{\text{CE}}$ or $\overline{\text{OE}}$ must be high when bank address is changed.

See "7. Toggle Bit I during Embedded Algorithm Operation Timing Diagram" in ■TIMING DIAGRAM for the Toggle Bit I timing specifications and diagrams.

16. DQ₅

Exceeded Timing Limits

 DQ_5 will indicate if the program or erase time has exceeded the specified limits (internal pulse count) . Under these conditions DQ_5 will produce a "1". This is a failure condition which indicates that the program or erase cycle was not successfully completed. Data Polling is the only operating function of the devices under this condition. The \overline{CE} circuit will partially power down the device under these conditions (to approximately 2 mA) . The \overline{OE} and \overline{WE} pins will control the output disable functions as described in "MBM29DL320TF/BF User Bus Operations Tables ($\overline{BYTE} = V_{IH}$ and $\overline{BYTE} = V_{IL}$)" (\blacksquare DEVICE BUS OPERATION).

The DQ_5 failure condition may also appear if a user tries to program a non blank location without erasing. In this case the devices lock out and never complete the Embedded Algorithm operation. Hence the system never reads a valid data on DQ_7 bit and DQ_6 never stops toggling. Once the devices have exceeded timing limits, the DQ_5 bit will indicate a "1." Please note that this is not a device failure condition since the devices were incorrectly used. If this occurs, reset the device with command sequence.

17. DQ₃

Sector Erase Timer

After the completion of the initial sector erase command sequence the sector erase time-out will begin. DQ_3 will remain low until the time-out is complete. Data Polling and Toggle Bit are valid after the initial sector erase command sequence.

If \overline{Data} Polling or the Toggle Bit I indicates the device has been written with a valid erase command, DQ₃ may be used to determine if the sector erase timer window is still open. If DQ₃ is high ("1") the internally controlled erase cycle has begun. If DQ₃ is low ("0"), the device will accept additional sector erase commands. To insure the command has been accepted, the system software should check the status of DQ₃ prior to and following each subsequent Sector Erase command. If DQ₃ were high on the second status check, the command may not have been accepted.

See "Hardware Sequence Flags Table".

18. DQ₂

Toggle Bit II

This toggle bit II, along with DQ₆, can be used to determine whether the devices are in the Embedded Erase Algorithm or in Erase Suspend.

Successive reads from the erasing sector will cause DQ_2 to toggle during the Embedded Erase Algorithm. If the devices are in the erase-suspended-read mode, successive reads from the erase-suspended sector will cause DQ_2 to toggle. When the devices are in the erase-suspended-program mode, successive reads from the byte address of the non-erase suspended sector will indicate a logic "1" at the DQ_2 bit.

 DQ_6 is different from DQ_2 in that DQ_6 toggles only when the standard program or Erase, or Erase Suspend Program operation is in progress. The behavior of these two status bits, along with that of DQ_7 , is summarized as follows:

For example DQ_2 and DQ_6 can be used together to determine if the erase-suspend-read mode is in progress. (DQ_2 toggles while DQ_6 does not.) See also "Toggle Bit Status Table" and "9. DQ_2 vs. DQ_6 " in \blacksquare TIMING DIAGRAM.

Furthermore DQ2 can also be used to determine which sector is being erased. When the device is in the erase mode, DQ2 toggles if this bit is read from an erasing sector.

To operate toggle bit function properly, \overline{CE} or \overline{OE} must be high when bank address is changed.

19. Reading Toggle Bits DQ6/DQ2

Whenever the system initially begins reading toggle bit status, it must read DQ_7 to DQ_0 at least twice in a row to determine whether a toggle bit is toggling. Typically a system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on DQ_7 to DQ_0 on the following read cycle.

However, after the initial two read cycles, if the system determines that the toggle bit is still toggling, the system also should note whether the value of DQ_5 is high (see "15. DQ_5 "). If it is, the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as DQ_5 went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not complete the operation successfully, and the system must write the reset command to return to reading array data.

The remaining scenario is that the system initially determines that the toggle bit is toggling and DQ₅ has not gone high. The system may continue to monitor the toggle bit and DQ₅ through successive read cycles, determining the status as described in the previous paragraph. Alternatively it may choose to perform other system tasks. In this case, the system must start at the beginning of the algorithm when it returns to determine the status of the operation. (Refer to "4. Toggle Bit Algorithm" in ■FLOW CHART.)

Toggle Bit Status Table

Mode	DQ ₇	DQ ₆	DQ₂
Program	ŪQ ₇	Toggle	1
Erase	0	Toggle	Toggle *
Erase-Suspend Read (Erase-Suspended Sector)	1	1	Toggle
Erase-Suspend Program	ŪQ ₇	Toggle	1 *

^{*:} Successive reads from the erasing or erase-suspend sector will cause DQ2 to toggle. Reading from non-erase suspend sector address will indicate logic "1" at the DQ2 bit.

20. RY/BY

Ready/Busy

The MBM29DL320TF/BF provide a RY/BY open-drain output pin as a way to indicate to the host system that the Embedded Algorithms are either in progress or has been completed. If the output is low, the devices are busy with either a program or erase operation. If the output is high, the devices are ready to accept any read/write or erase operation. If the MBM29DL320TF/BF are placed in an Erase Suspend mode, the RY/BY output will be high.

During programming, the RY/BY pin is driven low after the rising edge of the fourth write pulse. During an erase operation, the RY/BY pin is driven low after the rising edge of the sixth write pulse. The RY/BY pin will indicate a busy condition during the RESET pulse. Refer to "10. RY/BY Timing Diagram during Program/Erase Operations" and "11. RESET, RY/BY Timing Diagram" in ■TIMING DIAGRAM for a detailed timing diagram. The RY/BY pin is pulled high in standby mode.

Since this is an open-drain output, RY/BY pins can be tied together in parallel with a pull-up resistor to Vcc.

21. Data Protection

The MBM29DL320TF/BF are designed to offer protection against accidental erasure or programming caused by spurious system level signals that may exist during power transitions. During power up the devices automatically reset the internal state machine in the Read mode. Also, with its control register architecture, alteration of the memory contents only occurs after successful completion of specific multi-bus cycle command sequences.

The devices also incorporate several features to prevent inadvertent write cycles resulting form Vcc power-up and power-down transitions or system noise.

22. Low Vcc Write Inhibit

To avoid initiation of a write cycle during V_{CC} power-up and power-down, a write cycle is locked out for V_{CC} less than V_{LKO} (Min) . If $V_{\text{CC}} < V_{\text{LKO}}$, the command register is disabled and all internal program/erase circuits are disabled. Under this condition the device will reset to the read mode. Subsequent writes will be ignored until the V_{CC} level is greater than V_{LKO} . It is the users responsibility to ensure that the control pins are logically correct to prevent unintentional writes when V_{CC} is above V_{LKO} (Min) .

If Embedded Erase Algorithm is interrupted, there is possibility that the erasing sector (s) cannot be used.

23. Write Pulse "Glitch" Protection

Noise pulses of less than 3 ns (typical) on \overline{OE} , \overline{CE} , or \overline{WE} will not initiate a write cycle.

24. Logical Inhibit

Writing is inhibited by holding any one of $\overline{OE} = V_{IL}$, $\overline{CE} = V_{IH}$, or $\overline{WE} = V_{IH}$. To initiate a write cycle \overline{CE} and \overline{WE} must be a logic zero while \overline{OE} is a logic one.

25. Power-Up Write Inhibit

Power-up of the devices with $\overline{WE} = \overline{CE} = V_{\parallel}$ and $\overline{OE} = V_{\parallel}$ will not accept commands on the rising edge of \overline{WE} . The internal state machine is automatically reset to the read mode on power-up.

■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rat	Unit	
Farameter	Зуппоп	Min	Max	Oille
Storage Temperature	Tstg	-55	+125	°C
Ambient Temperature with Power Applied	TA	-40	+85	°C
Voltage with Respect to Ground All pins except A ₉ , OE, RESET *1,*2	VIN, VOUT	-0.5	Vcc + 0.5	V
Power Supply Voltage *1	Vcc	-0.5	+4.0	V
A ₉ , $\overline{\text{OE}}$, and $\overline{\text{RESET}}$ *1,*3	Vin	-0.5	+13.0	V
WP/ACC *1,*4	Vacc	-0.5	+10.5	V

^{*1:} Voltage is defined on the basis of Vss = GND = 0 V.

- *3: Minimum DC input voltage on A₉, $\overline{\text{OE}}$ and $\overline{\text{RESET}}$ pins is -0.5 V. During voltage transitions, A₉, $\overline{\text{OE}}$ and $\overline{\text{RESET}}$ pins may undershoot Vss to -2.0 V for periods of up to 20 ns. Voltage difference between input and supply voltage (V_{IN} Vcc) does not exceed +9.0 V. Maximum DC input voltage on A₉, $\overline{\text{OE}}$ and $\overline{\text{RESET}}$ pins is +13.0 V which may overshoot to +14.0 V for periods of up to 20 ns.
- *4: Minimum DC input voltage on WP/ACC pin is -0.5 V. During voltage transitions, WP/ACC pin may undershoot Vss to -2.0 V for periods of up to 20 ns. Maximum DC input voltage on WP/ACC pin is +10.5 V which may overshoot to +12.0 V for periods of up to 20 ns when Vcc is applied.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol Part No.		Va	Unit	
Farameter	Symbol	Part NO.	Min	Max	Oilit
Ambient Temperatuer	TA	MBM29DL320TF/BF 70/80/10	-40	+85	°C
Power Supply Voltage	Vcc	MBM29DL320TF/BF 70/80/10	+2.7	+3.1	V

Notes: • Voltage is defined on the basis of Vss = GND = 0 V.

• Operating ranges define those limits between which the functionality of the devices are guaranteed.

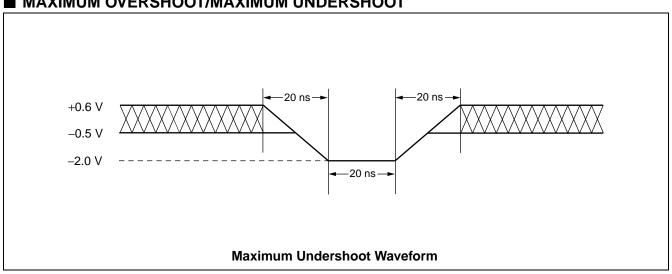
WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

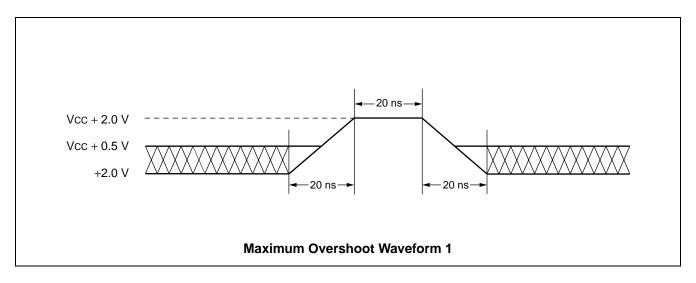
Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

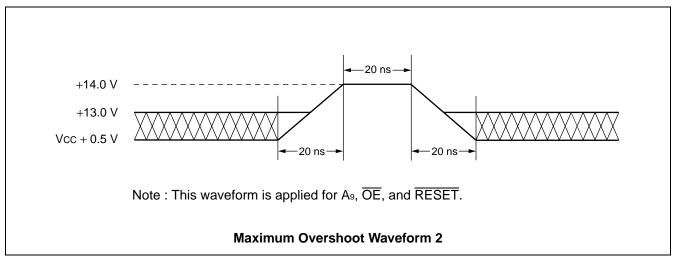
No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representatives beforehand.

^{*2:} Minimum DC voltage on input or I/O pins is -0.5 V. During voltage transitions, input or I/O pins may undershoot Vss to -2.0 V for periods of up to 20 ns. Maximum DC voltage on input or I/O pins is Vcc + 0.5 V. During voltage transitions, input or I/O pins may overshoot to Vcc + 2.0 V for periods of up to 20 ns.

■ MAXIMUM OVERSHOOT/MAXIMUM UNDERSHOOT







■ DC CHARACTERISTICS

Davamatav	Sym-	Conditions	Conditions			11:4:4
Parameter	bol	Conditions		Min	Max	Unit
Input Leakage Current	Iы	$V_{IN} = V_{SS}$ to V_{CC} , $V_{CC} = V_{CC}$	-1.0	+1.0	μΑ	
Output Leakage Current	ILO	Vout = Vss to Vcc, Vcc = Vcc	Max	-1.0	+1.0	μΑ
A ₉ , OE, RESET Inputs Leakage Current	Ішт	Vcc = Vcc Max, A ₉ , OE , RESET = 12.5 V			35	μΑ
		$\overline{CE} = V_{IL}, \overline{OE} = V_{IH},$ f = 5 MHz	Byte Word	_	16 18	mA
Vcc Active Current *1	Icc1	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH},$ f = 1 MHz	Byte Word		4	mA
Vcc Active Current *2	Icc2	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}$			35	mA
Vcc Current (Standby)	Іссз		_	5	μΑ	
Vcc Current (Standby, Reset)	Icc4	Vcc = Vcc Max, RESET = Vss	_	5	μΑ	
Vcc Current (Automatic Sleep Mode) *3	Icc5		_	5	μΑ	
Vcc Active Current *5 (Read-While-Program)	Icc6	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}$ Byte		_	51	mA
			Word	_	53	
Vcc Active Current *5 (Read-While-Erase)	Icc7	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}$	Byte Word	_	51 53	mA
Vcc Active Current (Erase-Suspend-Program)	Icc8	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}$	l		35	mA
ACC Accelerated Program Current	IACC	Vcc = Vcc Max, WP/ACC = Vacc Max		_	20	mA
Input Low Level	VIL	_		-0.5	+0.6	V
Input High Level	ViH	_		2.0	Vcc + 0.3	V
Voltage for WP/ACC Sector Protection/ Unprotection and Program Acceleration	Vacc	_		8.5	9.5	V
Voltage for Autoselect and Sector Protection (A ₉ , OE, RESET) *4	VID	_	11.5	12.5	V	
Output Low Voltage Level	Vol	IoL = 4.0 mA, Vcc = Vcc Min	_	0.45	V	
Output High Voltage Lavel	V _{OH1}	$I_{OH} = -2.0 \text{ mA}, V_{CC} = V_{CC} \text{ Min}$	า	2.4		V
Output High Voltage Level	V _{OH2}	Іон = -100 μА	Vcc - 0.4	_	V	
Low Vcc Lock-Out Voltage	VLKO	_		2.3	2.5	V

^{*1:} The lcc current listed includes both the DC operating current and the frequency dependent component.

^{*2:} Icc active while Embedded Algorithm (program or erase) is in progress.

^{*3:} Automatic sleep mode enables the low power mode when address remains stable for 150 ns.

^{*4:} Applicable for only Vcc applying.

^{*5:} Embedded Algorithm (program or erase) is in progress (@5 MHz).

■ AC CHARACTERISTICS

• Read Only Operations Characteristics

	Svi	Symbol								
Parameter	- Oyiliboi		Test setup	70		80		10		Unit
	JEDEC	Standard	4	Min	Max	Min	Max	Min	Max	
Read Cycle Time	tavav	t RC	_	70	_	80		100		ns
Address to Output Delay	t avqv	tacc	$\frac{\overline{CE}}{OE} = V_{IL}$	_	70	_	80	_	100	ns
Chip Enable to Output Delay	t ELQV	t ce	$\overline{OE} = V_{IL}$	_	70	_	80	_	100	ns
Output Enable to Output Delay	t GLQV	t oe	_		30		30		35	ns
Chip Enable to Output High-Z	t ehqz	t DF	_	_	25	_	30	_	30	ns
Output Enable to Output High-Z	t GHQZ	t DF	_	_	25	_	30	_	30	ns
Output Hold Time from Addresses, CE or OE, Whichever Occurs First	t axqx	tон	_	0		0	_	0		ns
RESET Pin Low to Read Mode	_	t READY	_	_	20	_	20	_	20	μs
CE to BYTE Switching Low or High		telfl, telfh	_		5		5		5	ns

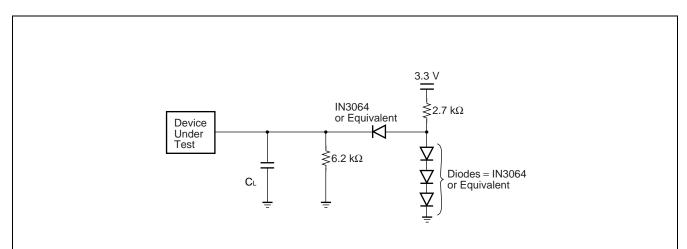
*: Test Conditions:

Output Load: 1 TTL gate and 30 pF (MBM29DL320TF/BF 70)

1 TTL gate and 100 pF (MBM29DL320TF/BF 80/10)

Input rise and fall times: 5 ns Input pulse levels: 0.0 V or 3.0 V Timing measurement reference level

> Input: 1.5 V Output: 1.5 V



Notes : $C_L = 30$ pF including jig capacitance (MBM29DL320TF70, MBM29DL320BF70) $C_L = 100$ pF including jig capacitance (MBM29DL320TF80/10, MBM29DL320BF80/10)

Test Conditions

• Write/Erase/Program Operations

	e/Program Operations Parameter	Syr	nbol		70			80			10		Unit
'	rarameter	JEDEC	Standard	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
Write Cycle Time	Э	tavav	twc	70	_	_	80	_	_	100	_	_	ns
Address Setup T	ime	t avwl	t as	0	_		0	_		0	_	_	ns
Address Setup T Toggle Bit Pollin	ime to OE Low During	_	t ASO	12			15			15			ns
Address Hold Ti	me	twlax	t AH	45	_	_	45	_	_	50	_	_	ns
Address Hold Ti During Toggle B	me from CE or OE High it Polling	_	t aht	0			0			0			ns
Data Setup Time)	tоvwн	t DS	30			30			50			ns
Data Hold Time		twhox	tон	0			0	_		0		_	ns
Output Enable	Read		t	0			0	_		0		_	ns
Hold Time	Toggle and Data Polling	Ī —	t oeh	10			10			10			ns
CE High During	Toggle Bit Polling	_	t CEPH	20	_	_	20	_	_	20	_	_	ns
OE High During	Toggle Bit Polling	_	t oeph	20			20			20			ns
Read Recover T	ime Before Write	t GHWL	t GHWL	0			0			0			ns
Read Recover T	ime Before Write	t GHEL	t GHEL	0		_	0	_	_	0		_	ns
CE Setup Time		telwl	t cs	0			0			0			ns
WE Setup Time		twlel	tws	0			0			0			ns
CE Hold Time		twheh	tсн	0	_		0	_		0	_	_	ns
WE Hold Time		t EHWH	twн	0	_		0	_		0		_	ns
Write Pulse Wid	th	twlwh	twp	35			35			50			ns
CE Pulse Width		teleh	t cp	35			35	_		50		_	ns
Write Pulse Wid	th High	twhwl	t wph	25			30	_		30		_	ns
CE Pulse Width	High	tehel	t cph	25	_	_	30	_	_	30	_	_	ns
Programming	Byte	twhwh1	twhwh1	_	8	_		8	_	_	8	_	μs
Operation	Word	LVVHVVH1	tvvHvvH1		16			16			16		μs
Sector Erase Op	eration *1	twhwh2	t whwh2		0.2			0.2			0.2		S
Vcc Setup Time		_	tvcs	50			50			50			μs
Rise Time to V _{ID}	*2	_	tvidr	500		_	500		_	500			ns
Rise Time to Vac	cc *3	_	tvaccr	500	_	_	500	_	_	500	_	_	ns
Voltage Transition	on Time *2	_	t vlht	4	_	_	4	_	_	4	_	_	μs
Write Pulse Wid	th *2	_	twpp	100		_	100		_	100			μs
OE Setup Time	to WE Active *2	_	toesp	4			4	_		4			μs

(Continued)

(Continued)

Parameter	Symbol		70		80			10			Unit	
i didiletei	JEDEC	Standard	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Oilit
CE Setup Time to WE Active *2		t csp	4	_		4			4	_		μs
Recover Time from RY/BY	_	t RB	0	_		0	_		0			ns
RESET Pulse Width	_	t RP	500	_		500	_		500			ns
RESET High Level Period before Read		tпн	200			200	—		200			ns
BYTE Switching Low to Output High-Z	_	t FLQZ		_	30		_	30			30	ns
BYTE Switching High to Output Active	_	t FHQV		_	70		_	80			100	ns
Program/Erase Valid to RY/BY Delay	_	t BUSY	—	-	90		—	90			90	ns
Delay Time from Embedded Output Enable	_	t EOE	_	_	70	_	_	80	_	_	100	ns
Erase Time-Out Time	_	t TOW	50			50	—		50			μs
Erase Suspend Transition Time	_	t spd			20		_	20		_	20	μs

^{*1:} Does not include the preprogramming time.

^{*2:} For Sector Group Protection operation.

^{*3:} This timing is limited for Accelerated Program operation only.

■ ERASE AND PROGRAMMING PERFORMANCE

Parameter	Parameter Limits Unit		Linit	Comments	
raiailletei	Min	Тур	Max	Oilit	Comments
Sector Erase Time		0.2	1.0	s	Excludes programming time prior to erasure
Word Programming Time		6.0	60	μs	Excludes system-level
Byte Programming Time	_	4.0	48	μs	overhead
Chip Programming Time	_	_	100	S	Excludes system-level overhead
Program/Erase Cycle	100,000	_	_	cycle	_

Notes: • Typical Erase conditions T_A = +25 °C, Vcc = 2.9 V

• Typical Program conditions T_A = +25 °C, Vcc = 2.9 V, Data = checker

■ TSOP (I) PIN CAPACITANCE

Parameter	Symbol	Condition	Va	Unit	
raiailletei	Syllibol	Condition	Тур	Max	Oille
Input Capacitance	Cin	V _{IN} = 0	6.0	7.5	pF
Output Capacitance	Соит	Vout = 0	8.5	12.0	pF
Control Pin Capacitance	C _{IN2}	V _{IN} = 0	8.0	11.0	pF
WP/ACC Pin Capacitance	Сімз	V _{IN} = 0	9.0	11.0	pF

Notes: • Test conditions T_A = +25 °C, f = 1.0 MHz

• DQ₁₅/A₋₁ pin capacitance is stipulated by output capacitance.

■ FBGA PIN CAPACITANCE

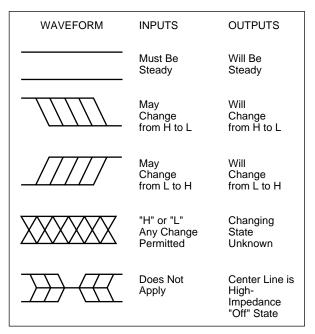
Parameter	Parameter Symbol Condition		Va	Unit	
raiametei	Symbol	Condition	Тур	Max	Oilit
Input Capacitance	Cin	V _{IN} = 0	6.0	7.5	pF
Output Capacitance	Соит	V _{OUT} = 0	8.5	12.0	pF
Control Pin Capacitance	C _{IN2}	V _{IN} = 0	8.0	11.0	pF
WP/ACC Pin Capacitance	Сімз	V _{IN} = 0	9.0	11.0	pF

Notes : • Test conditions $T_A = +25$ °C, f = 1.0 MHz

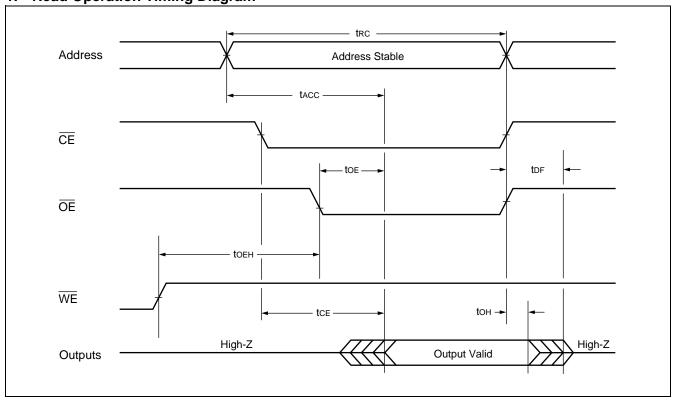
• DQ₁₅/A₋₁ pin capacitance is stipulated by output capacitance.

■ TIMING DIAGRAM

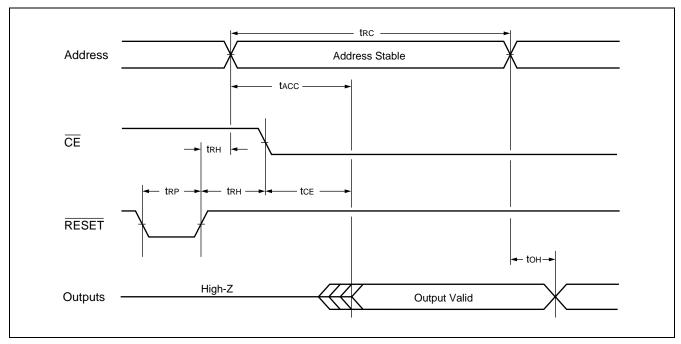
• Key to Switching Waveforms



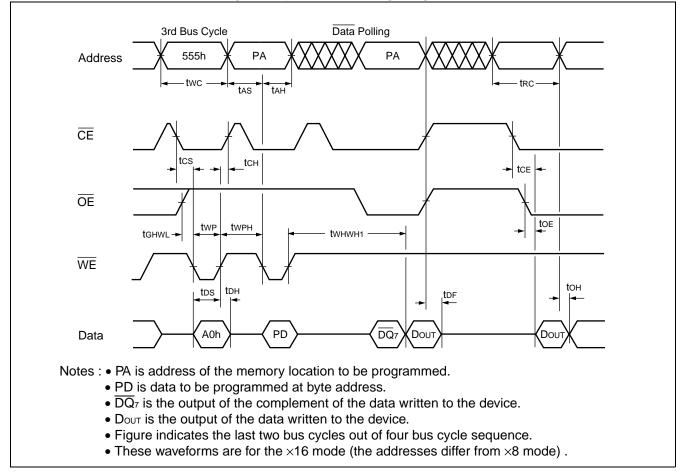
1. Read Operation Timing Diagram



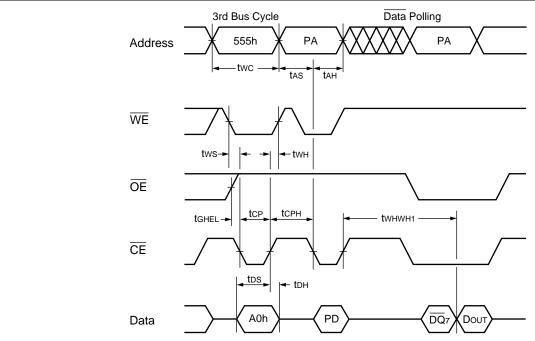
2. Hardware Reset/Read Operation Timing Diagram



3. Alternate WE Controlled Program Operation Timing Diagram



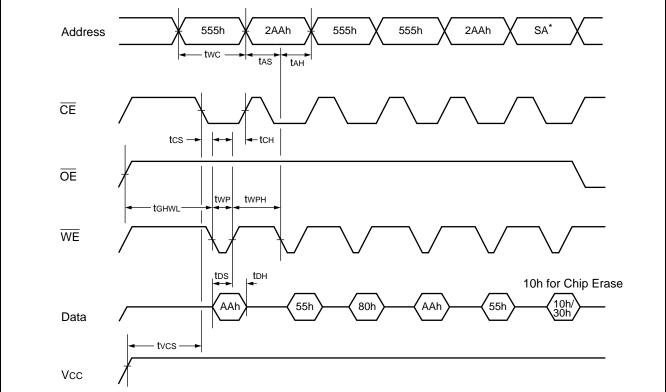




Notes : • PA is address of the memory location to be programmed.

- PD is data to be programmed at byte address.
- \overline{DQ}_7 is the output of the complement of the data written to the device.
- Dout is the output of the data written to the device.
- Figure indicates the last two bus cycles out of four bus cycle sequence.
- These waveforms are for the ×16 mode (the addresses differ from ×8 mode) .

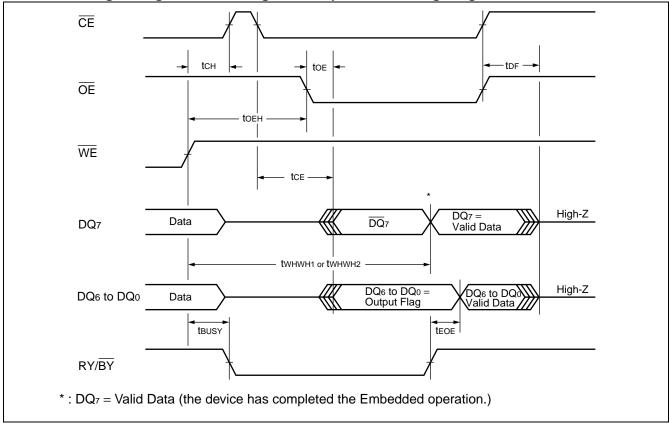
5. Chip/Sector Erase Operation Timing Diagram



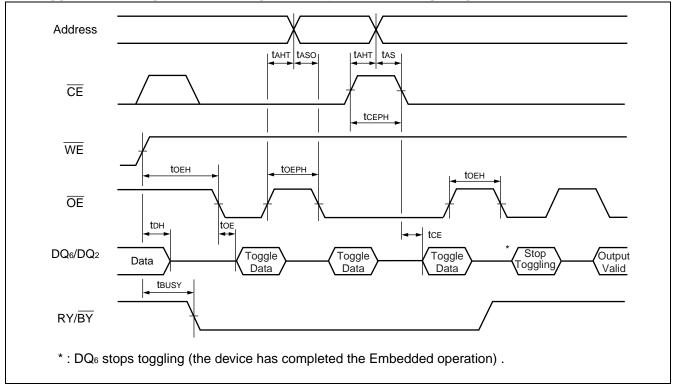
*: SA is the sector address for Sector Erase. Addresses = 555h (Word), AAAh (Byte) for Chip Erase.

Note : These waveforms are for the $\times 16$ mode (the addresses differ from $\times 8$ mode) .

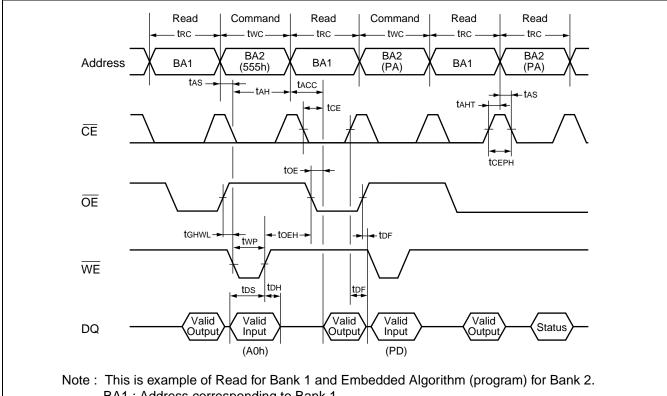
6. Data Polling during Embedded Algorithm Operation Timing Diagram



7. Toggle Bit I during Embedded Algorithm Operation Timing Diagram

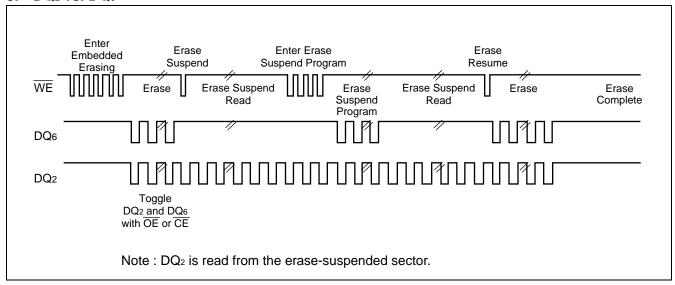




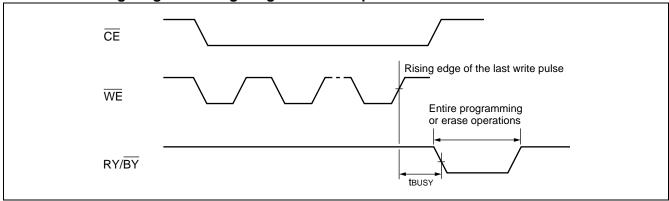


BA1 : Address corresponding to Bank 1 BA2 : Address corresponding to Bank 2

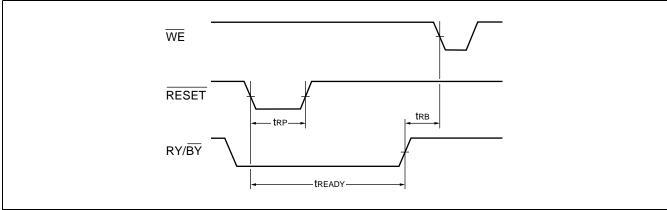
9. DQ₂ vs. DQ₆



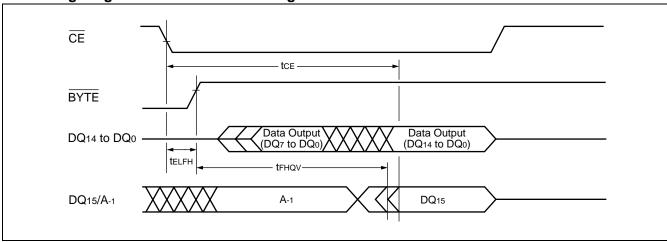
10. RY/BY Timing Diagram during Program/Erase Operations



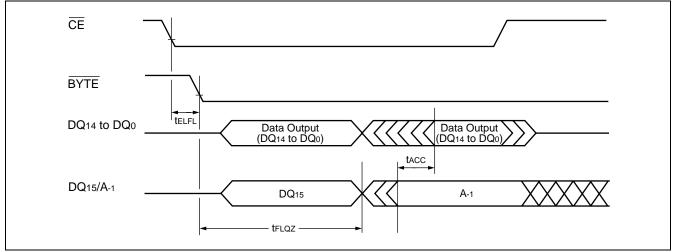
11. RESET, RY/BY Timing Diagram



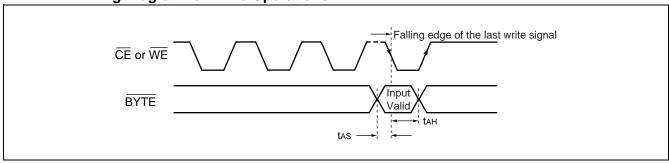
12. Timing Diagram for Word Mode Configuration

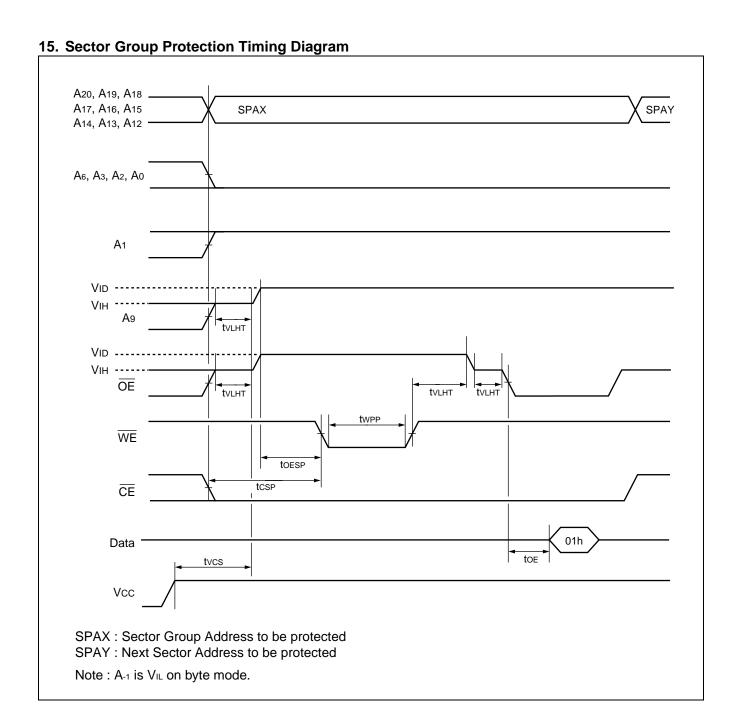


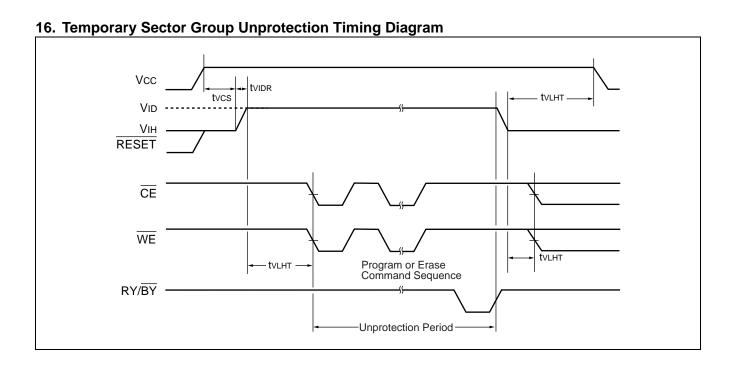
13. Timing Diagram for Byte Mode Configuration

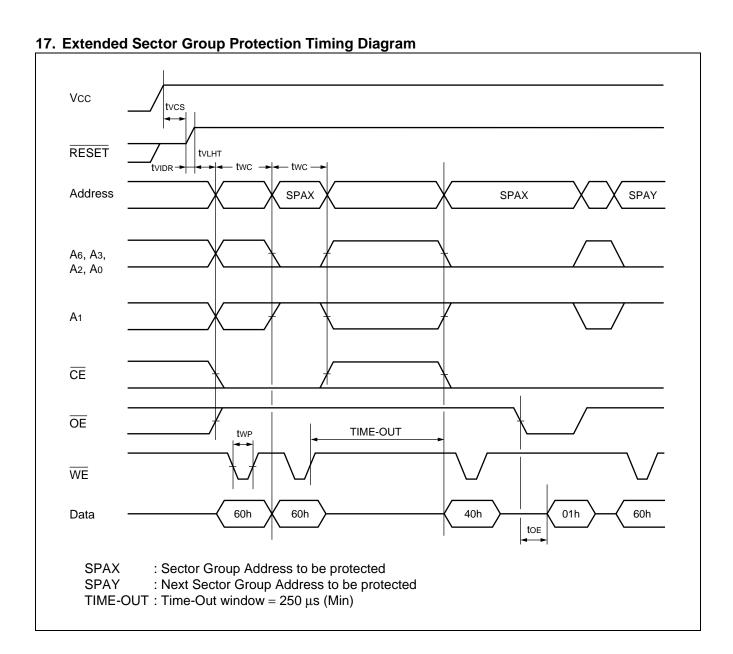


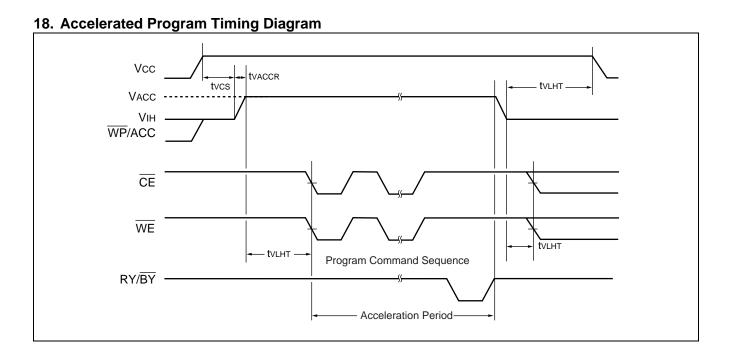
14. BYTE Timing Diagram for Write Operations





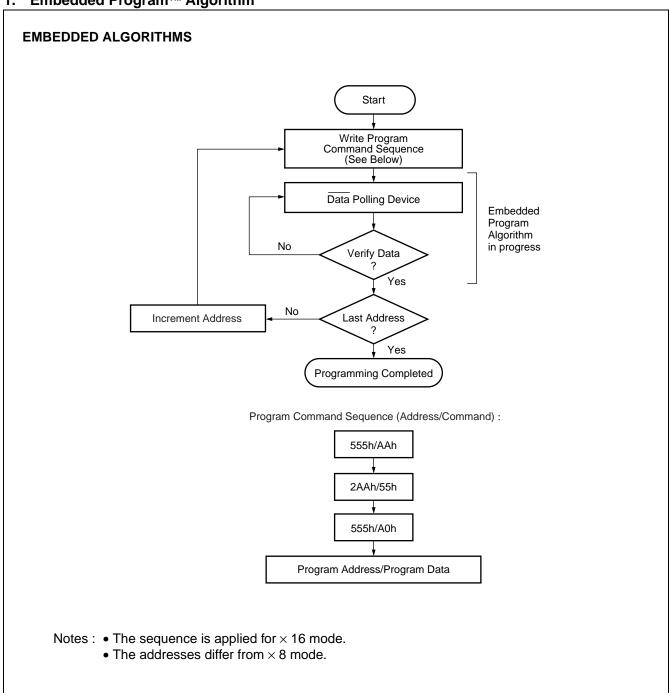




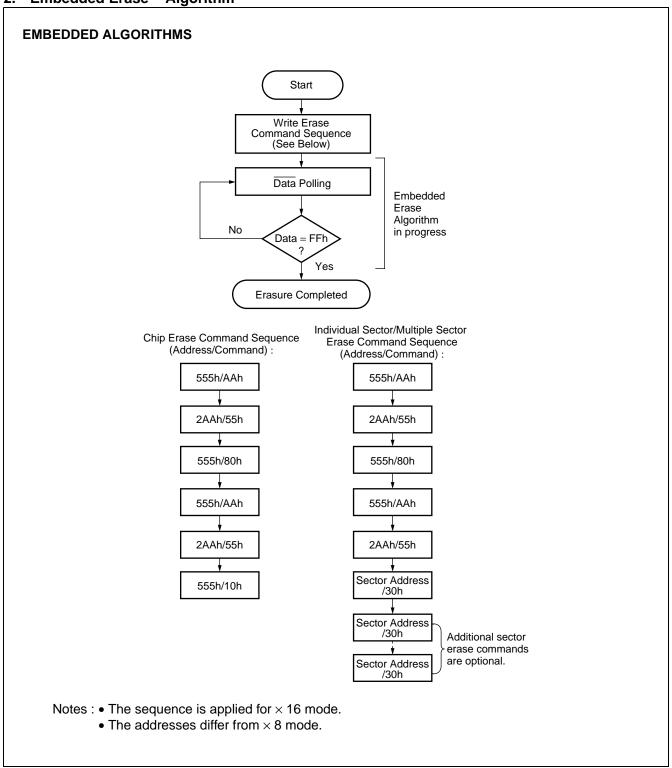


■ FLOW CHART

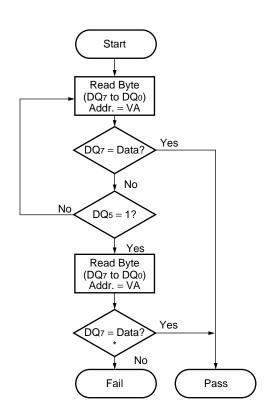
Embedded Program™ Algorithm



2. Embedded Erase™ Algorithm



3. Data Polling Algorithm

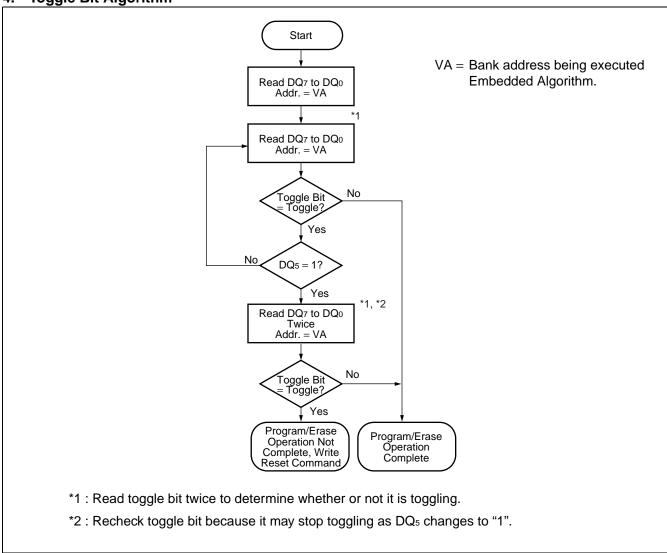


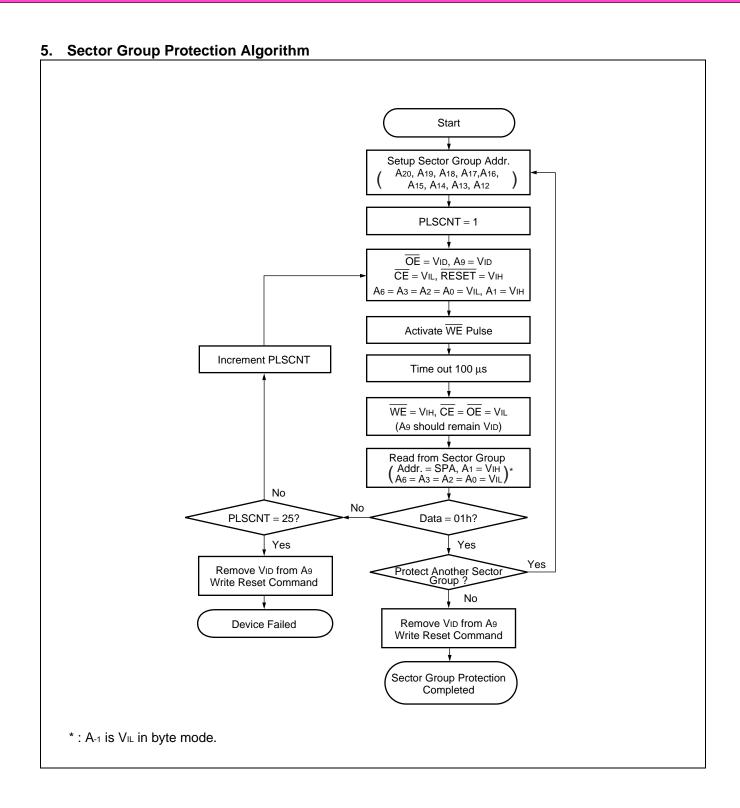
VA = Address for programming

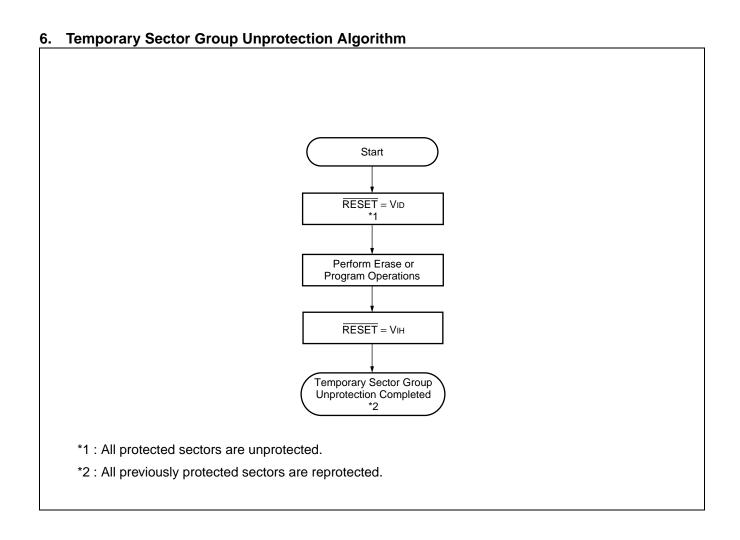
- Any of the sector addresses within the sector being erased during sector erase or multiple erases operation.
- Any of the sector addresses within the sector not being protected during sector erase or multiple sector erases operation.

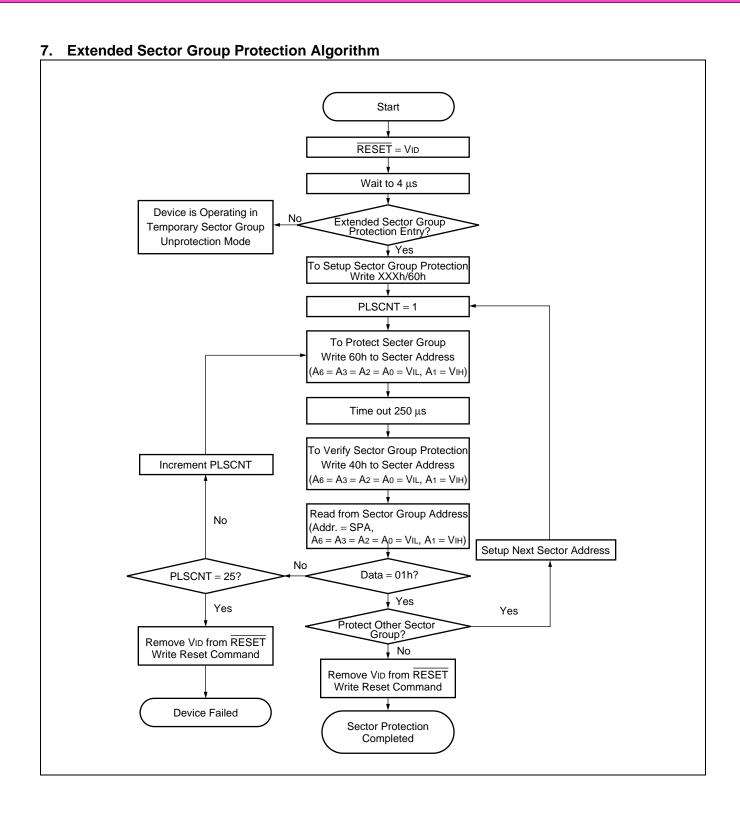
* : DQ_7 is rechecked even if DQ_5 = "1" because DQ_7 may change simultaneously with DQ_5 .

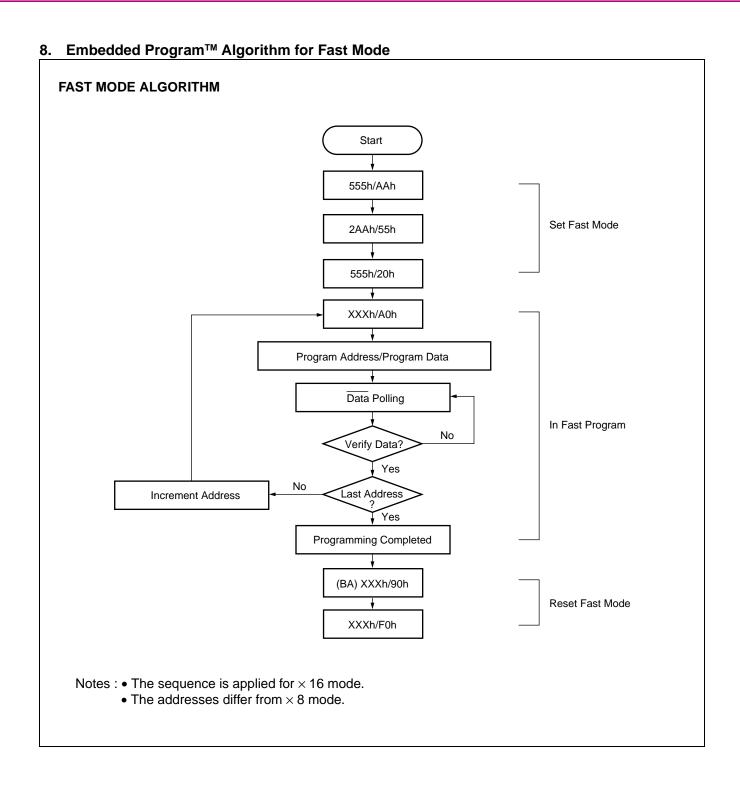
4. Toggle Bit Algorithm







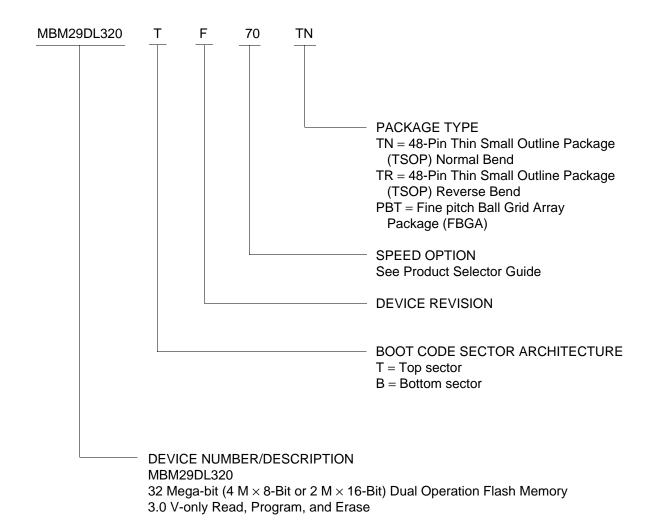




■ ORDERING INFORMATION

Standard Products

Fujitsu standard products are available in several packages. The order number is formed by a combination of:

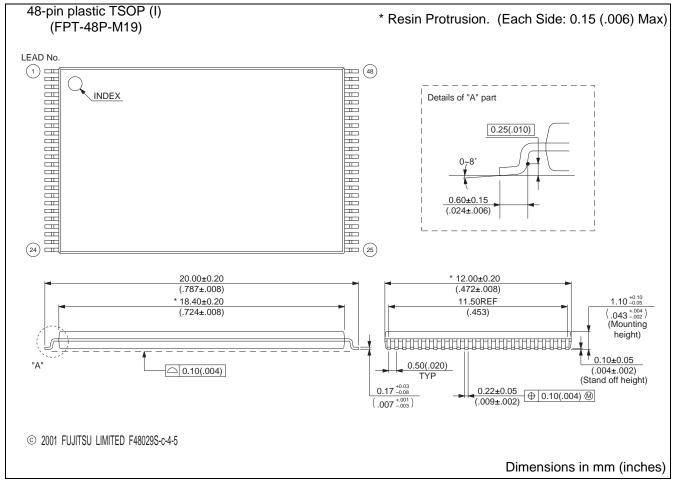


Valid Combinations					
	70	TN			
MBM29DL320TF/BF	80	TR			
	10	PBT			

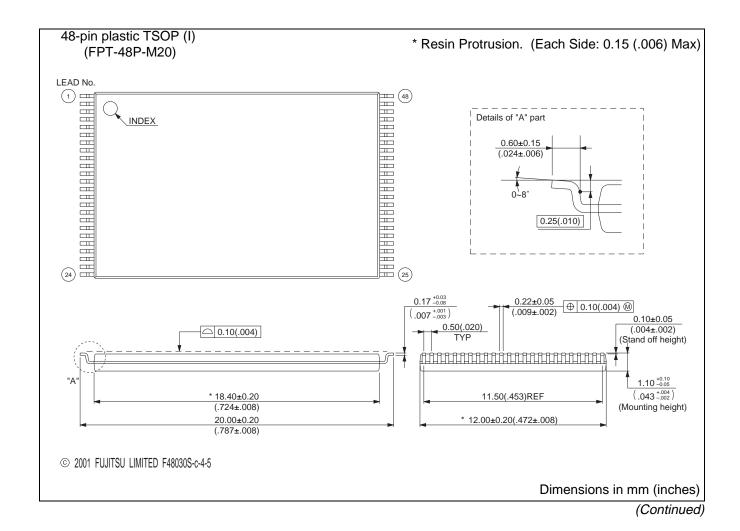
Valid Combinations

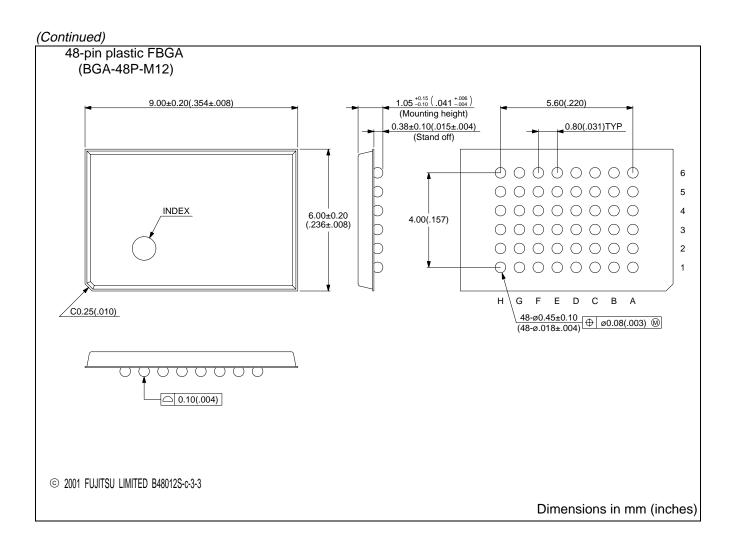
Valid Combinations list configurations planned to be supported in volume for this device. Consult the local Fujitsu sales office to confirm availability of specific valid combinations and to check on newly released combinations.

■ PACKAGE DIMENSIONS



(Continued)





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